

THS6212 Differential Broadband PLC Line Driver Amplifier

1 Features

- Low power consumption:
 - Full-bias mode: 23 mA
 - Mid-bias mode: 17.5 mA
 - Low-bias mode: 11.9 mA
 - Low-power shutdown mode
 - IADJ pin for variable bias
- Low noise:
 - Voltage noise: 2.5 nV/√Hz
 - Inverting current noise: 18 pA/√Hz
 - Noninverting current noise: 1.4 pA/√Hz
- Low distortion:
 - –86-dBc HD2 (1-MHz, 100-Ω differential load)
 - –101-dBc HD3 (1-MHz, 100-Ω differential load)
- High output current: > 665 mA (25-Ω load)
- Wide output swing:
 - 49 V_{PP} (28-V, 100-Ω differential load)
- Wide bandwidth: 205 MHz (G_{DIFF} = 10 V/V)
- PSRR: >55 dB at 1 MHz for good isolation
- Wide power-supply range: 10 V to 28 V
- Thermal protection: 175°C (typical)
- Alternative device with integrated common-mode buffer: [THS6222](#)

2 Applications

- [High-voltage, high-current driving](#)
- [Wide-band, power-line communications](#)

3 Description

The THS6212 is a differential line-driver amplifier with a current-feedback architecture. The device is targeted for use in broadband, wideband power line communications (PLC) line driver applications and is fast enough to support transmissions of 14.5-dBm line power up to 30 MHz.

The unique architecture of the THS6212 uses minimal quiescent current and still achieves very high linearity. Differential distortion under full bias conditions is –86-dBc at 1 MHz and reduces to only –71 dBc at 10 MHz. Fixed multiple bias settings allow for enhanced power savings for line lengths where the full performance of the amplifier is not required. To allow for even more flexibility and power savings, an adjustable current pin (IADJ) is available to further lower the bias currents.

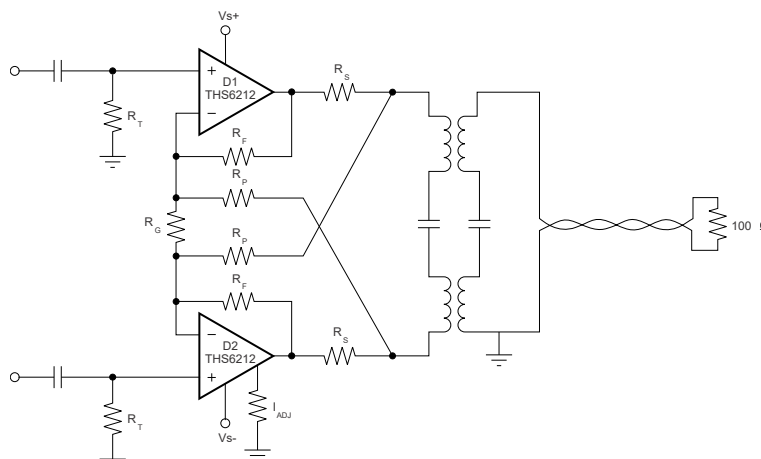
The wide output swing of 49 V_{PP} (100-Ω differential load) with 28-V power supplies, coupled with over a 650-mA current drive (25-Ω load), allows for wide dynamic headroom that keeps distortion minimal.

The THS6212 is available in a 24-pin VQFN package.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
THS6212	VQFN (24)	5.00 mm × 4.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.



Typical Line-Driver Circuit Using the THS6212



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

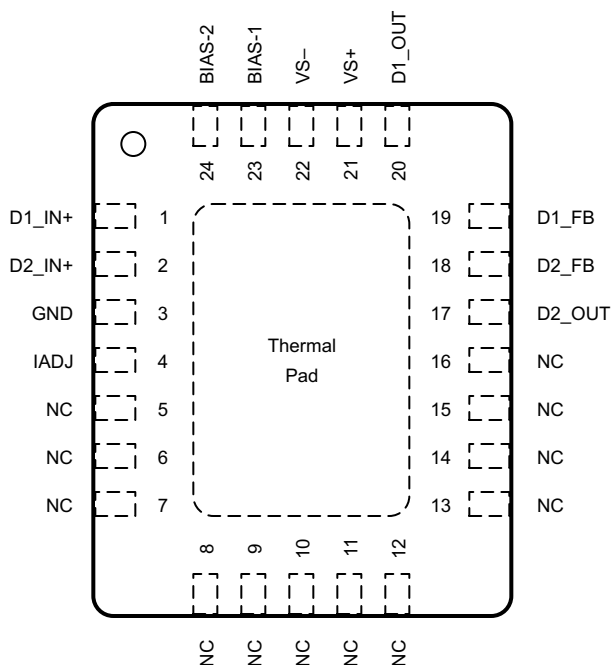
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• Updated the numbering format for tables, figures, and cross-references throughout the document.....	1
• Changed mid-bias mode value from 17.7 mA to 17.5 mA in <i>Features</i> list	1
• Changed low-bias mode value from 12.2 mA to 11.9 mA in <i>Features</i> list	1
• Changed voltage noise value from 2.7 nV/ $\sqrt{\text{Hz}}$ to 2.5 nV/ $\sqrt{\text{Hz}}$ in <i>Features</i> list	1
• Changed inverting current noise value from 17 pA/ $\sqrt{\text{Hz}}$ to 18 pA/ $\sqrt{\text{Hz}}$ in <i>Features</i> list	1
• Changed noninverting current noise value from 1.2 pA/ $\sqrt{\text{Hz}}$ to 1.4 pA/ $\sqrt{\text{Hz}}$ in <i>Features</i> list	1
• Changed HD2 distortion from -100 dBc to -86 dBc in <i>Features</i> list	1
• Changed HD3 distortion from -89 dBc -101 dBc in <i>Features</i> list	1
• Changed output current from > 416 mA to > 665 mA in <i>Features</i> list	1
• Changed output swing from 43.2 Vpp to 49 Vpp in <i>Features</i> list	1
• Changed bandwidth from 150 MHz to 205 MHz in <i>Features</i> list	1
• Changed PSRR from 50 dB to > 55 dB in <i>Features</i> list	1
• Changed thermal protection from 170°C to 175°C in <i>Features</i> list	1
• Changed differential distortion to HD2 and updated values in <i>Description</i> section.....	1
• Changed output swing from 43.2Vpp to 49Vpp in <i>Description</i> section.....	1
• Changed power supplies from $\pm 12\text{-V}$ to 28-V in <i>Description</i> section.....	1
• Changed current drive from 416-mA to 650-mA in <i>Description</i> section.....	1
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• Changed <i>Typical Line-Driver Circuit Using the THS6212</i> figure.....	1
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• Deleted Output current, IO from Absolute Maximum Ratings.....	6
• Added Bias control pin voltage in <i>Absolute Maximum Ratings</i>	6
• Added Input voltage to all pins except VS+, VS-, and BIAS control in <i>Absolute Maximum Ratings</i>	6
• Added Input current limit in <i>Absolute Maximum Ratings</i>	6
• Changed Maximum junction, TJ from 130 C to 125 C in <i>Absolute Maximum Ratings</i>	6
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• Changed $R_{\Theta JC(Top)}$ from 31.7 °C/W to 32.8 °C/W in <i>Thermal Information</i>	6
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• Changed ψ_{JT} from 0.4 °C/W to 3.8 °C/W in <i>Thermal Information</i>	6
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• Changed current drive from 416 mA to 650 mA in <i>Overview</i> section.....	20
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• Changed 7 nV/ $\sqrt{Hz}$ calculation to 6.5 nV/ $\sqrt{Hz}$ in <i>Differential Noise Performance</i> section.....	22
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• Changed 23 mA to 19.5 mA, 24 V to 28 V and 1003 mW to 11 mW in <i>Computing Total Driver Power for Line-Driving Applications</i>	30
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• Added last two <i>Features</i> bullets	1
• Added last paragraph to <i>Overview</i> section	20

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- Changed *Dual-Supply Downstream Driver* figure.....[27](#)
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5 Pin Configuration and Functions



NC = no internal connection.

Figure 5-1. RHF Package 24-Pin VQFN With Exposed Thermal Pad Top View

Table 5-1. Pin Functions⁽¹⁾

PIN		I/O	DESCRIPTION
NAME	NO.		
BIAS-1	23	I	Bias mode parallel control, LSB
BIAS-2	24	I	Bias mode parallel control, MSB
D1_FB	19	I	Amplifier D1 inverting input
D2_FB	18	I	Amplifier D2 inverting input
D1_IN+	1	I	Amplifier D1 noninverting input
D2_IN+	2	I	Amplifier D2 noninverting input
D1_OUT	20	O	Amplifier D1 output
D2_OUT	17	O	Amplifier D2 output
GND ⁽²⁾	3	I/O	Control pin ground reference
IADJ	4	I/O	Bias current adjustment pin
NC	5-16	—	No internal connection
VS–	22	I/O	Negative power-supply connection
VS+	21	I/O	Positive power-supply connection

(1) The THS6212 defaults to the shutdown (disable) state if a signal is not present on the bias pins.

(2) The GND pin ranges from VS– to (VS+ – 5 V).

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Voltage	Supply voltage, $V_S = (V_{S+}) - (V_{S-})$		28	V
	Bias control pin voltage, referenced to GND pin	0	14.5	V
	All pins except V_{S+} , V_{S-} , and BIAS control	$(V_{S-}) - 0.5$	$(V_{S+}) + 0.5$	V
	Differential input voltage (each amplifier), V_{ID}		±2	V
Current	All input pins, current limit		±10	mA
	Continuous power dissipation ⁽²⁾	See Thermal Information table		
Temperature	Maximum junction, T_J (under any condition) ⁽³⁾		150	°C
	Maximum junction, T_J (continuous operation, long-term reliability) ⁽⁴⁾		125	
	Storage, T_{stg}	–65	150	

- (1) Stresses beyond those listed under [Absolute Maximum Rating](#) may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under [Recommended Operating Condition](#). Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The THS6212 incorporates a thermal pad on the underside of the device. This pad functions as a heatsink and must be connected to a thermally dissipating plane for proper power dissipation. Failure to do so can result in exceeding the maximum junction temperature, which can permanently damage the device.
- (3) The absolute maximum junction temperature under any condition is limited by the constraints of the silicon process.
- (4) The absolute maximum junction temperature for continuous operation is limited by the package constraints. Operation above this temperature can result in reduced reliability or lifetime of the device

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±2000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_S	Supply voltage, $V_S = (V_{S+}) - (V_{S-})$	10		28	V
GND	GND pin voltage	V_{S-}		$V_{S+} - 5$	V
T_J	Operating junction temperature			125	°C
T_A	Ambient operating air temperature	–40	25	85	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		THS6212	UNIT
		RHF (VQFN)	
		24 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	42.3	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	32.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	20.9	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	3.8	°C/W
Υ_{JB}	Junction-to-board characterization parameter	20.9	°C/W

6.4 Thermal Information (continued)

THERMAL METRIC ⁽¹⁾		THS6212	UNIT
		RHF (VQFN)	
		24 PINS	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	9.5	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics: $V_S = 12\text{ V}$

at $T_A \approx 25^\circ\text{C}$, differential closed-loop gain (A_V) = 10 V/V, differential load (R_L) = 50 Ω , series isolation resistor (R_S) = 2.5 Ω each, $R_F = 1.24\text{ k}\Omega$, $R_{ADJ} = 0\text{ }\Omega$, $V_O = D1_OUT - D2_OUT$, and full bias (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
AC PERFORMANCE							
SSBW	Small-signal bandwidth	$A_V = 5\text{ V/V}$, $R_F = 1.5\text{ k}\Omega$, $V_O = 2\text{ V}_{PP}$		250		MHz	
		$A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $V_O = 2\text{ V}_{PP}$		180			
		$A_V = 15\text{ V/V}$, $R_F = 1\text{ k}\Omega$, $V_O = 2\text{ V}_{PP}$		165			
	0.1-dB bandwidth flatness			17		MHz	
LSBW	Large-signal bandwidth	$V_O = 16\text{ V}_{PP}$		195		MHz	
SR	Slew rate (20% to 80%)	$V_O = 16\text{-V step}$		5500		V/ μs	
	Rise and fall time (10% to 90%)	$V_O = 2\text{ V}_{PP}$		2.1		ns	
HD2	2nd-order harmonic distortion	$A_V = 10\text{ V/V}$, $V_O = 2\text{ V}_{PP}$, $R_L = 50\text{ }\Omega$	Full bias, $f = 1\text{ MHz}$	−80		dBc	
			Mid bias, $f = 1\text{ MHz}$	−78			
			Low bias, $f = 1\text{ MHz}$	−78			
			Full bias, $f = 10\text{ MHz}$	−61			
			Mid bias, $f = 10\text{ MHz}$	−61			
			Low bias, $f = 10\text{ MHz}$	−61			
HD3	3rd-order harmonic distortion	$A_V = 10\text{ V/V}$, $V_O = 2\text{ V}_{PP}$, $R_L = 50\text{ }\Omega$	Full bias, $f = 1\text{ MHz}$	−90		dBc	
			Mid bias, $f = 1\text{ MHz}$	−86			
			Low bias, $f = 1\text{ MHz}$	−83			
			Full bias, $f = 10\text{ MHz}$	−69			
			Mid bias, $f = 10\text{ MHz}$	−65			
			Low bias, $f = 10\text{ MHz}$	−62			
e_n	Differential input voltage noise	$f \geq 1\text{ MHz}$, input-referred		2.5		nV/ $\sqrt{\text{Hz}}$	
i_{n+}	Noninverting input current noise	$f \geq 1\text{ MHz}$, each amplifier		1.4		pA/ $\sqrt{\text{Hz}}$	
i_{n-}	Inverting input current noise	$f \geq 1\text{ MHz}$, each amplifier		18		pA/ $\sqrt{\text{Hz}}$	
DC PERFORMANCE							
Z_{OL}	Open-loop transimpedance gain			1300		k Ω	
	Input offset voltage (each amplifier)			±12		mV	
		$T_A = -40^\circ\text{C}$		±16			
		$T_A = 85^\circ\text{C}$		±11			
	Noninverting input bias current			±1		μA	
		$T_A = -40^\circ\text{C}$		±1			
		$T_A = 85^\circ\text{C}$		±1			
	Inverting input bias current			±8		μA	
		$T_A = -40^\circ\text{C}$		±7			
		$T_A = 85^\circ\text{C}$		±4			
INPUT CHARACTERISTICS							

6.5 Electrical Characteristics: $V_S = 12\text{ V}$ (continued)

at $T_A \approx 25^\circ\text{C}$, differential closed-loop gain (A_V) = 10 V/V, differential load (R_L) = 50 Ω , series isolation resistor (R_S) = 2.5 Ω each, $R_F = 1.24\text{ k}\Omega$, $R_{ADJ} = 0\text{ }\Omega$, $V_O = D1_OUT - D2_OUT$, and full bias (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
	Common-mode input range	Each input with respect to midsupply		± 3.0		V
CMRR	Common-mode rejection ratio	Each input		64		dB
		$T_A = -40^\circ\text{C}$		67		
		$T_A = 85^\circ\text{C}$		62		
	Noninverting differential input resistance			$10 \parallel 2$		k $\Omega \parallel$ pF
	Inverting input resistance			43		Ω
OUTPUT CHARACTERISTICS						
V_O	Output voltage swing	$R_L = 100\text{ }\Omega$, $R_S = 0\text{ }\Omega$		± 9.7		V
		$R_L = 50\text{ }\Omega$, $R_S = 0\text{ }\Omega$		± 9.3		
		$R_L = 25\text{ }\Omega$, $R_S = 0\text{ }\Omega$		± 8.4		
I_O	Output current (sourcing and sinking)	$R_L = 25\text{ }\Omega$, $R_S = 0\text{ }\Omega$, based on V_O specification		± 338		mA
	Short-circuit output current			± 0.81		A
Z_O	Closed-loop output impedance	$f = 1\text{ MHz}$, differential		0.03		Ω
POWER SUPPLY						
V_S	Operating voltage		10	12	28	V
		$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	10		28	
GND	GND pin voltage		V_{S-}	0	$V_{S+} - 5$	V
I_{S+}	Quiescent current	Full bias (BIAS-1 = 0, BIAS-2 = 0)		19.5		mA
		Mid bias (BIAS-1 = 1, BIAS-2 = 0)		15		
		Low bias (BIAS-1 = 0, BIAS-2 = 1)		10.4		
		Bias off (BIAS-1 = 1, BIAS-2 = 1)		0.8		
I_{S-}	Quiescent current	Full bias (BIAS-1 = 0, BIAS-2 = 0)		18.8		mA
		Mid bias (BIAS-1 = 1, BIAS-2 = 0)		14.4		
		Low bias (BIAS-1 = 0, BIAS-2 = 1)		9.6		
		Bias off (BIAS-1 = 1, BIAS-2 = 1)		0.01		
	Current through GND pin	Full bias (BIAS-1 = 0, BIAS-2 = 0)		0.8		mA
+PSRR	Positive power-supply rejection ratio	Differential		83		dB
-PSRR	Negative power-supply rejection ratio	Differential		83		dB
BIAS CONTROL						
	Bias control pin voltage range	With respect to GND pin, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	0	3.3	12	V
	Bias control pin logic threshold	Logic 1, with respect to GND pin, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	2.1			V
		Logic 0, with respect to GND pin, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$			0.8	
	Bias control pin current ⁽¹⁾	BIAS-1, BIAS-2 = 0.5 V (logic 0)		-9.6		μA
		BIAS-1, BIAS-2 = 3.3 V (logic 1)		0.3	1	
	Open-loop output impedance	Off bias (BIAS-1 = 1, BIAS-2 = 1)		$70 \parallel 5$		M $\Omega \parallel$ pF

(1) Current is considered positive out of the pin.

6.6 Electrical Characteristics: $V_S = 28\text{ V}$

at $T_A \approx 25^\circ\text{C}$, differential closed-loop gain (A_V) = 10 V/V, differential load (R_L) = 100 Ω , $R_F = 1.24\text{ k}\Omega$, $R_{ADJ} = 0\text{ }\Omega$, $V_O = D1_OUT - D2_OUT$, and full bias (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
AC PERFORMANCE							
SSBW	Small-signal bandwidth, –3 dB	A _V = 5 V/V, R _F = 1.5 kΩ, V _O = 2 V _{PP}		285			MHz
		A _V = 10 V/V, R _F = 1.24 kΩ, V _O = 2 V _{PP}		205			
	0.1-dB bandwidth flatness			13			MHz
LSBW	Large-signal bandwidth	V _O = 40 V _{PP}		170			MHz
SR	Slew rate (20% to 80% level)	V _O = 40-V step		11,000			V/μs
	Rise and fall time	V _O = 2 V _{PP}		2			ns
HD2	2nd-order harmonic distortion	A _V = 10 V/V, V _O = 2 V _{PP} , R _L = 100 Ω	Full bias, f = 1 MHz	–86			dBc
			Low bias, f = 1 MHz	–79			
			Full bias, f = 10 MHz	–71			
			Low bias, f = 10 MHz	–63			
HD3	3rd-order harmonic distortion	A _V = 10 V/V, V _O = 2 V _{PP} , R _L = 100 Ω	Full bias, f = 1 MHz	–101			dBc
			Low bias, f = 1 MHz	–88			
			Full bias, f = 10 MHz	–80			
			Low bias, f = 10 MHz	–65			
e _n	Differential input voltage noise	f ≥ 1 MHz, input-referred		2.5			nV/√Hz
i _{n+}	Noninverting input current noise (each amplifier)	f ≥ 1 MHz		1.7			pA/√Hz
i _{n-}	Inverting input current noise (each amplifier)	f ≥ 1 MHz		18			pA/√Hz
DC PERFORMANCE							
Z _{OL}	Open-loop transimpedance gain			1500			kΩ
	Input offset voltage			±12			mV
	Input offset voltage drift	T _A = –40°C to +85°C		–40			μV/°C
	Input offset voltage matching	Amplifier A to B		±0.5			mV
	Noninverting input bias current			±1			μA
	Inverting input bias current			±6			μA
	Inverting input bias current matching			±8			μA
INPUT CHARACTERISTICS							
	Common-mode input range	Each input		±9	±10		V
CMRR	Common-mode rejection ratio	Each input		53	65		dB
	Noninverting input resistance			10 2			kΩ pF
	Inverting input resistance			38			Ω
OUTPUT CHARACTERISTICS							
V _O	Output voltage swing ⁽¹⁾	R _L = 100 Ω		±24.5			V
		R _L = 25 Ω		±12.3			
I _O	Output current (sourcing and sinking) ⁽¹⁾	R _L = 25 Ω, based on V _O specification		±580	±665		mA
	Short-circuit output current			1			A
Z _O	Output impedance	f = 1 MHz, differential		0.01			Ω

6.6 Electrical Characteristics: $V_S = 28\text{ V}$ (continued)

at $T_A \approx 25^\circ\text{C}$, differential closed-loop gain (A_V) = 10 V/V, differential load (R_L) = 100 Ω , $R_F = 1.24\text{ k}\Omega$, $R_{ADJ} = 0\text{ }\Omega$, $V_O = D1_OUT - D2_OUT$, and full bias (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER SUPPLY						
V_S	Operating voltage		10	12	28	V
		$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	10		28	
I_{S+}	Quiescent current	Full bias (BIAS-1 = 0, BIAS-2 = 0)		23		mA
		Mid bias (BIAS-1 = 1, BIAS-2 = 0)		17.5		
		Low bias (BIAS-1 = 0, BIAS-2 = 1)		11.9		
		Bias off (BIAS-1 = 1, BIAS-2 = 1)		1.1	1.3	
I_{S-}	Quiescent current	Full bias (BIAS-1 = 0, BIAS-2 = 0)		22		mA
		Mid bias (BIAS-1 = 1, BIAS-2 = 0)		16.4		
		Low bias (BIAS-1 = 0, BIAS-2 = 1)		10.8		
		Bias off (BIAS-1 = 1, BIAS-2 = 1)		0.1	0.8	
	Current through GND pin	Full bias (BIAS-1 = 0, BIAS-2 = 0)		1		mA
+PSRR	Positive power-supply rejection ratio	Differential		83		dB
-PSRR	Negative power-supply rejection ratio	Differential		77		dB
BIAS CONTROL						
	Bias control pin range	With respect to GND pin, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	0	3.3	14.5	V
	Bias control pin logic threshold	Logic 1, with respect to GND pin, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	1.9			V
		Logic 0, with respect to GND pin, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$			0.8	
	Bias control pin current ⁽²⁾	BIAS-1, BIAS-2 = 0.5 V (logic 0)	-15	-10		μA
		BIAS-1, BIAS-2 = 3.3 V (logic 1)		0.1	1	

(1) See [Section 7.3.1](#) for output voltage vs output current characteristics.

(2) Current is considered positive out of the pin.

6.7 Timing Requirements

		MIN	NOM	MAX	UNIT
t_{ON}	Turnon time delay: time for output to start tracking the input		25		ns
t_{OFF}	Turnoff time delay: time for output to stop tracking the input		275		ns

6.8 Typical Characteristics: $V_S = 12\text{ V}$

At $T_A \approx 25^\circ\text{C}$, $A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $R_L = 50\text{ }\Omega$, $R_S = 2.5\text{ }\Omega$, $R_{ADJ} = 0\text{ }\Omega$, full-bias mode (unless otherwise noted).

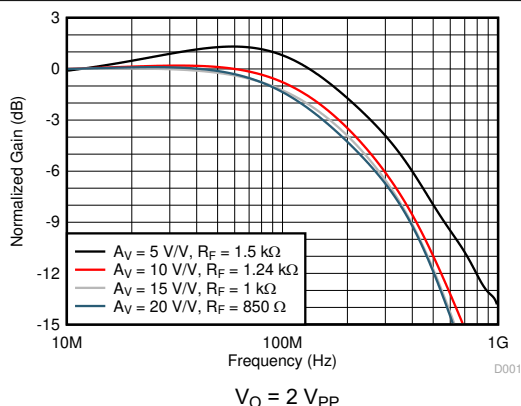


Figure 6-1. Small-Signal Frequency Response

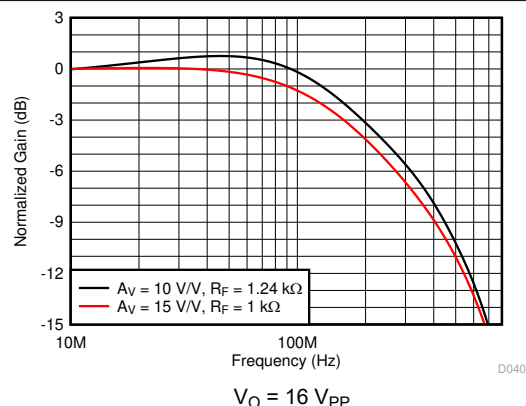
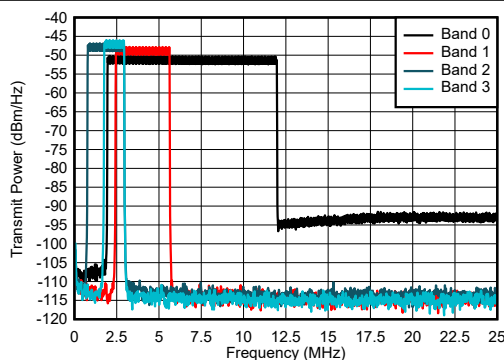


Figure 6-2. Large-Signal Frequency Response



SGCC HPLC profiles, crest factor = 5 V/V

Figure 6-3. Out-of-Band Suppression

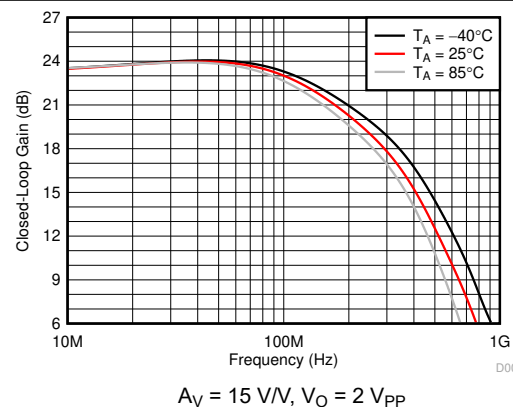


Figure 6-4. Small-Signal Frequency Response vs Temperature

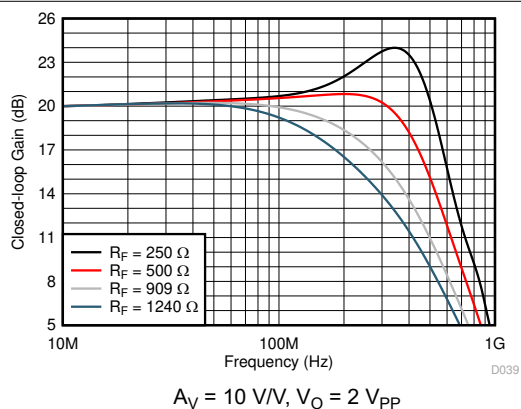


Figure 6-5. Small-Signal Frequency Response vs R_F

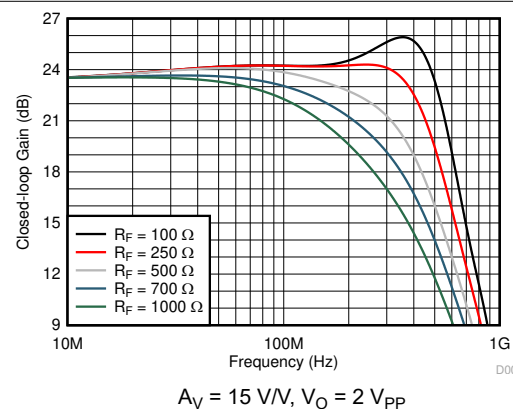


Figure 6-6. Small-Signal Frequency Response vs R_F

6.8 Typical Characteristics: $V_S = 12\text{ V}$ (continued)

At $T_A \approx 25^\circ\text{C}$, $A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $R_L = 50\text{ }\Omega$, $R_S = 2.5\text{ }\Omega$, $R_{ADJ} = 0\text{ }\Omega$, full-bias mode (unless otherwise noted).

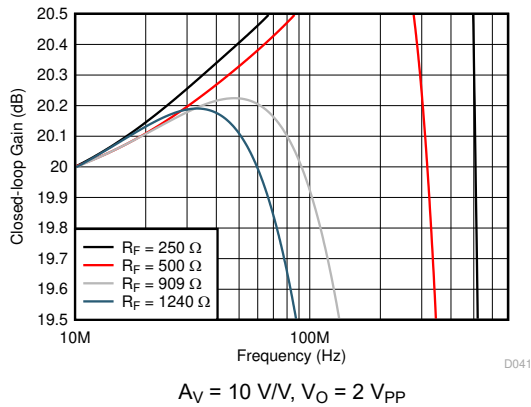


Figure 6-7. Small-Signal Gain Flatness vs R_F

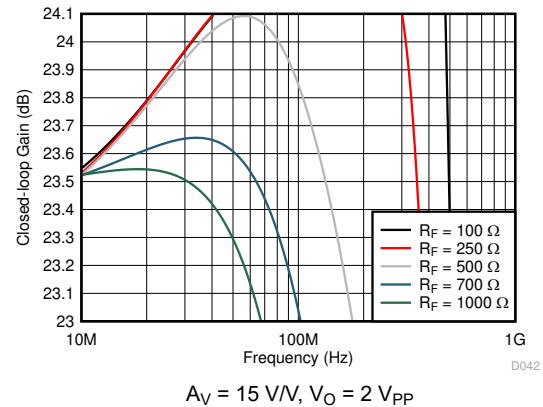


Figure 6-8. Small-Signal Gain Flatness vs R_F

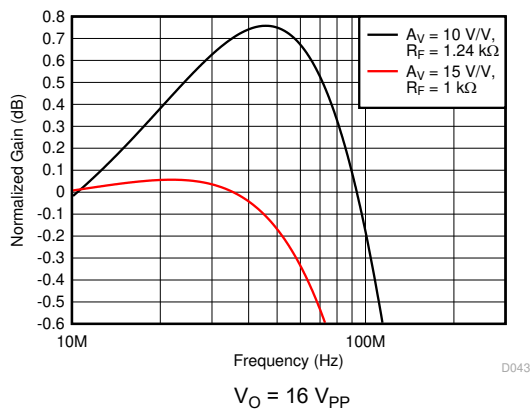
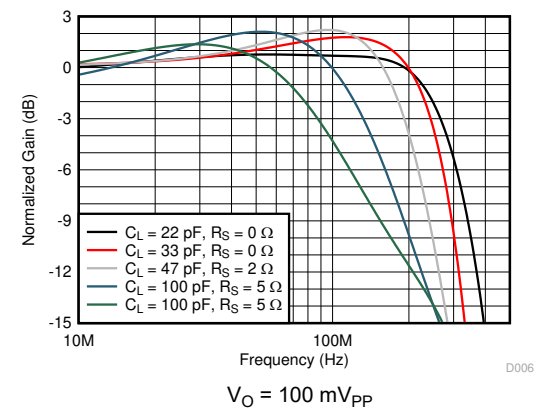


Figure 6-9. Large-Signal Gain Flatness



Frequency response is measured at the device output pin before the isolation resistor.

Figure 6-10. Small-Signal Frequency Response vs C_{LOAD}

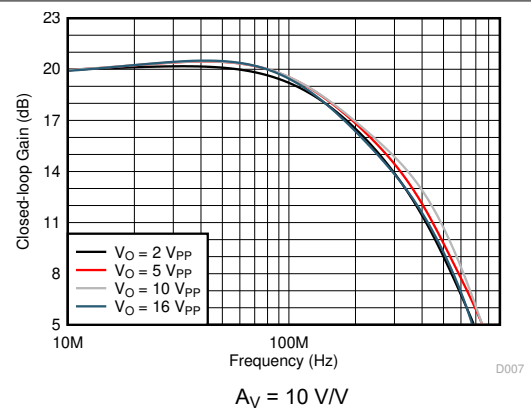


Figure 6-11. Large-Signal Frequency Response vs V_O

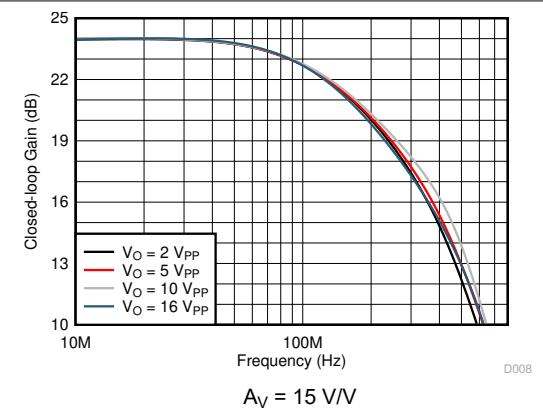


Figure 6-12. Large-Signal Frequency Response vs V_O

6.8 Typical Characteristics: $V_S = 12\text{ V}$ (continued)

At $T_A \approx 25^\circ\text{C}$, $A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $R_L = 50\ \Omega$, $R_S = 2.5\ \Omega$, $R_{ADJ} = 0\ \Omega$, full-bias mode (unless otherwise noted).

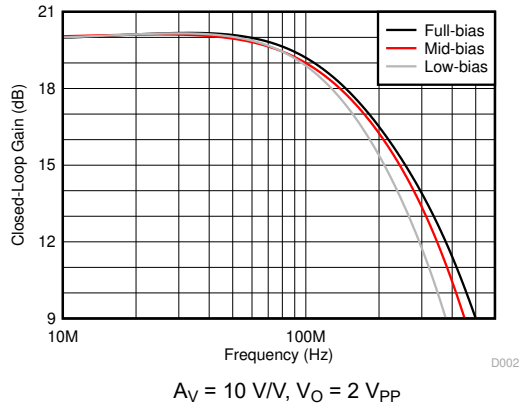


Figure 6-13. Small-Signal Frequency Response vs Bias Modes

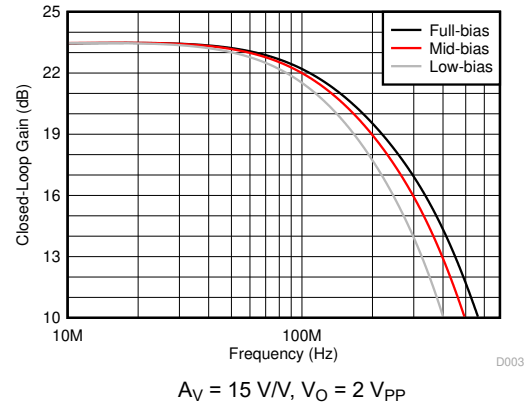


Figure 6-14. Small-Signal Frequency Response vs Bias Modes

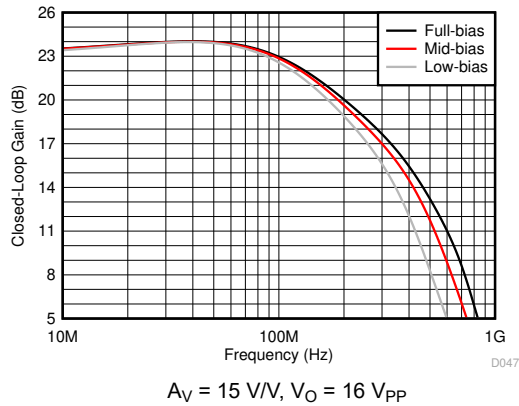


Figure 6-15. Large-Signal Frequency Response vs Bias Modes

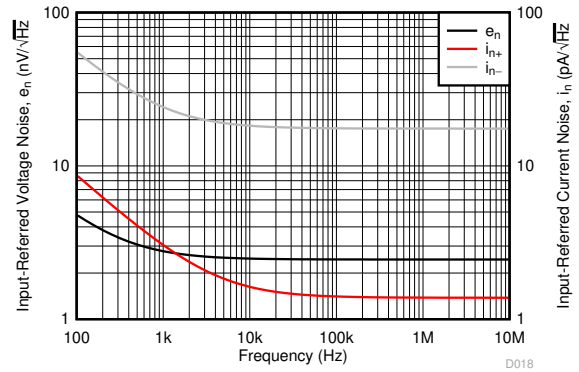


Figure 6-16. Input Voltage and Current Noise Density vs Frequency

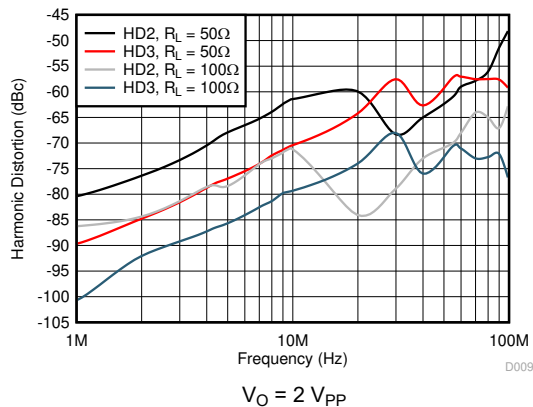


Figure 6-17. Harmonic Distortion vs Frequency

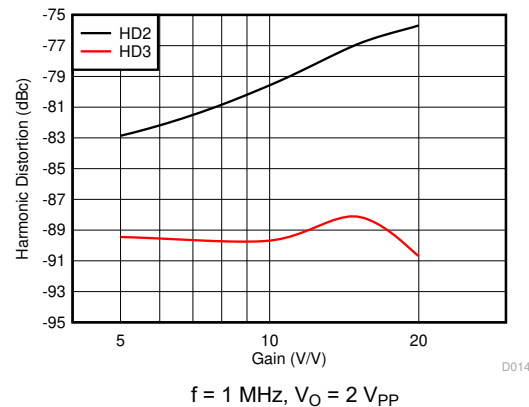


Figure 6-18. Harmonic Distortion vs Gain

6.8 Typical Characteristics: $V_S = 12\text{ V}$ (continued)

At $T_A \approx 25^\circ\text{C}$, $A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $R_L = 50\text{ }\Omega$, $R_S = 2.5\text{ }\Omega$, $R_{ADJ} = 0\text{ }\Omega$, full-bias mode (unless otherwise noted).

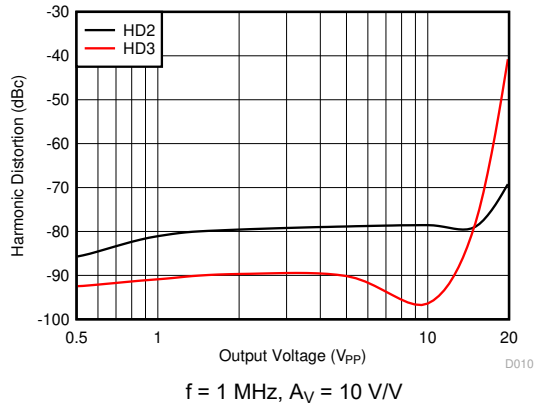


Figure 6-19. Harmonic Distortion vs V_O

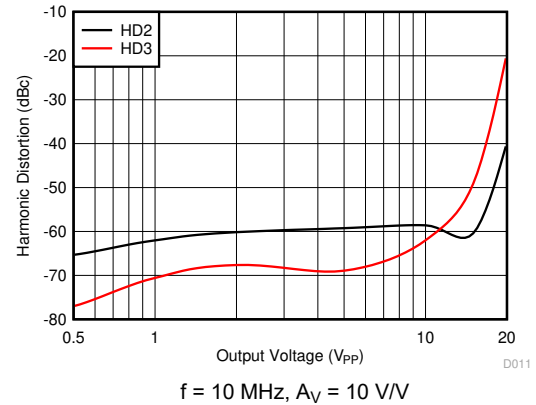


Figure 6-20. Harmonic Distortion vs V_O

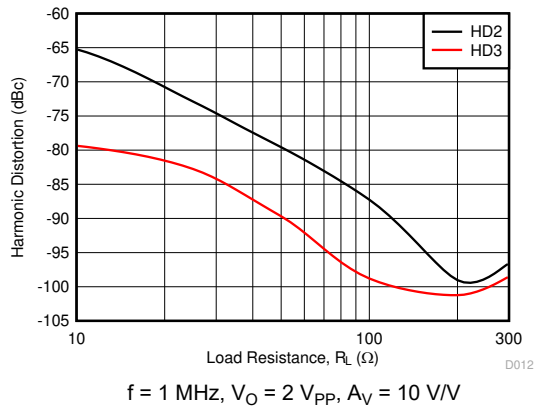


Figure 6-21. Harmonic Distortion vs R_L

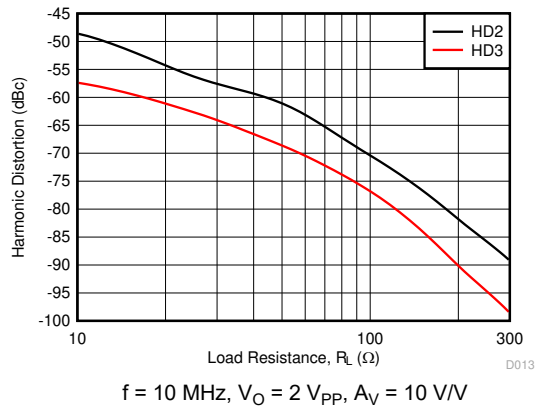


Figure 6-22. Harmonic Distortion vs R_L

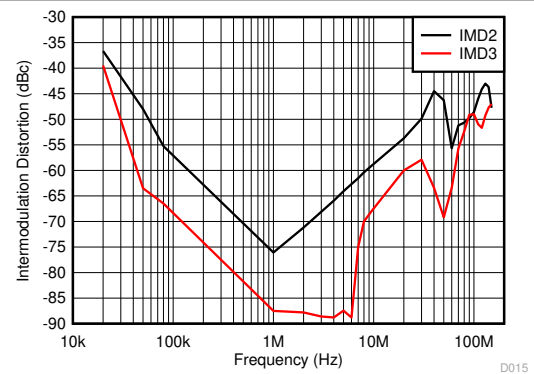


Figure 6-23. Intermodulation Distortion vs Frequency

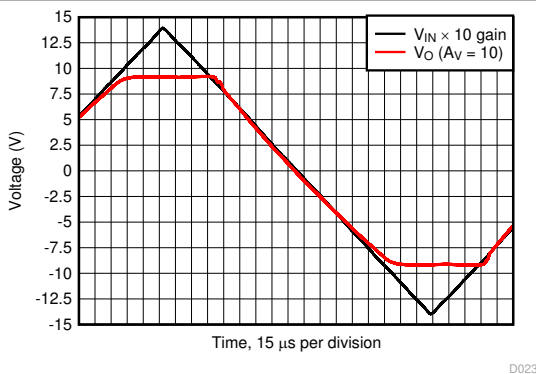
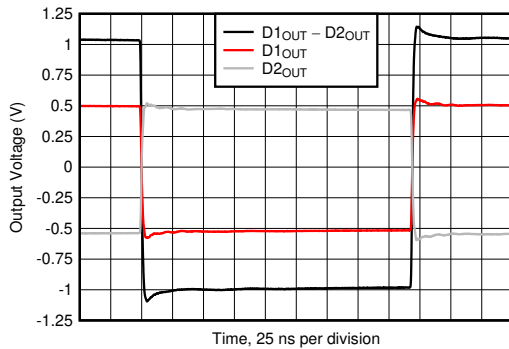


Figure 6-24. Overdrive Recovery

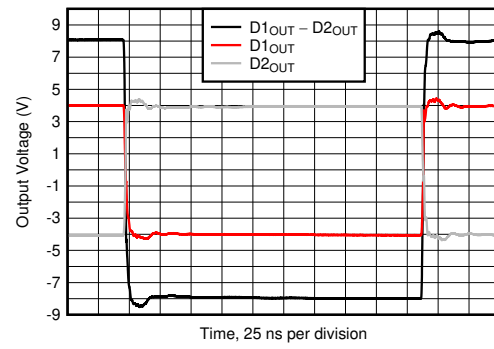
6.8 Typical Characteristics: $V_S = 12\text{ V}$ (continued)

At $T_A \approx 25^\circ\text{C}$, $A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $R_L = 50\text{ }\Omega$, $R_S = 2.5\text{ }\Omega$, $R_{ADJ} = 0\text{ }\Omega$, full-bias mode (unless otherwise noted).



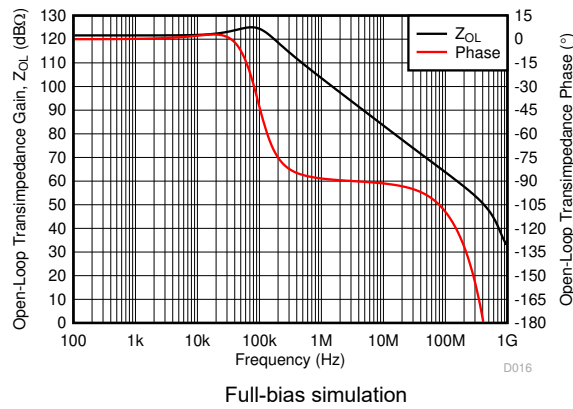
V_O step = 2 V_{PP}

Figure 6-25. Small-Signal Pulse Response



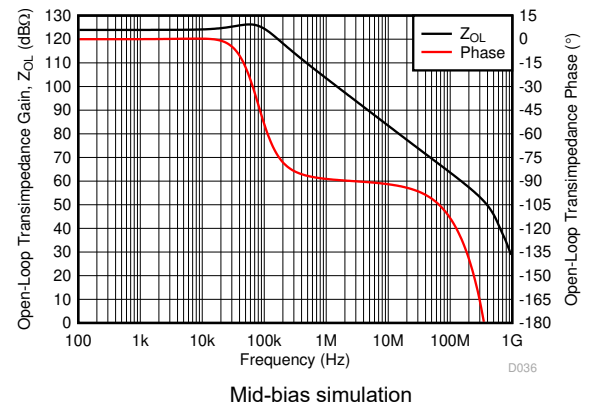
V_O step = 16 V_{PP}

Figure 6-26. Large-Signal Pulse Response



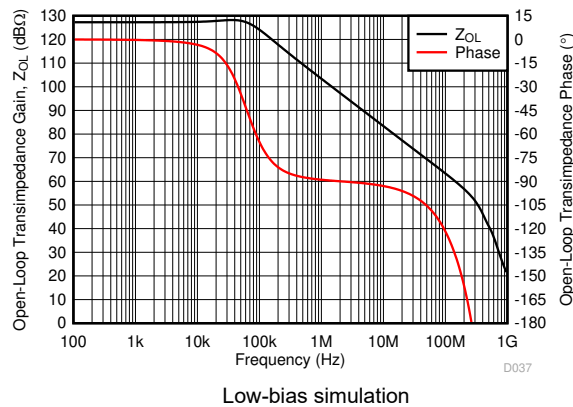
Full-bias simulation

Figure 6-27. Open-Loop Transimpedance Gain and Phase vs Frequency



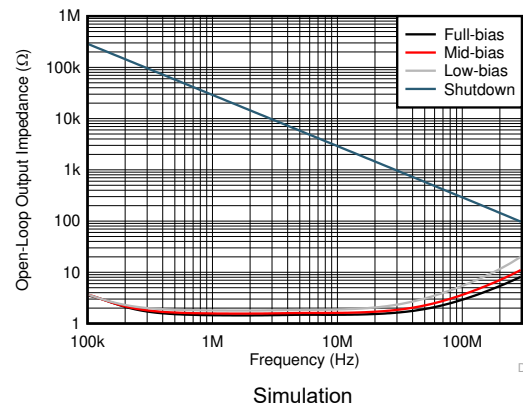
Mid-bias simulation

Figure 6-28. Open-Loop Transimpedance Gain and Phase vs Frequency



Low-bias simulation

Figure 6-29. Open-Loop Transimpedance Gain and Phase vs Frequency



Simulation

Figure 6-30. Open-Loop Output Impedance vs Frequency

6.8 Typical Characteristics: $V_S = 12\text{ V}$ (continued)

At $T_A \approx 25^\circ\text{C}$, $A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $R_L = 50\text{ }\Omega$, $R_S = 2.5\text{ }\Omega$, $R_{ADJ} = 0\text{ }\Omega$, full-bias mode (unless otherwise noted).

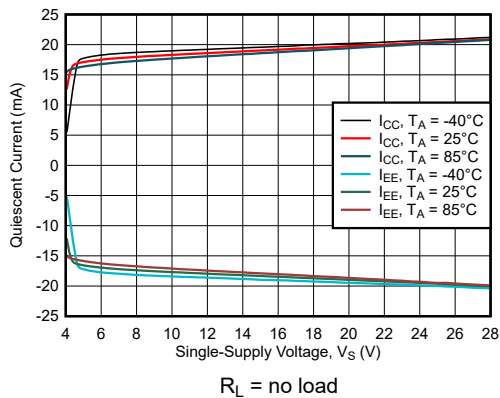


Figure 6-31. Quiescent Current vs Single-Supply Voltage

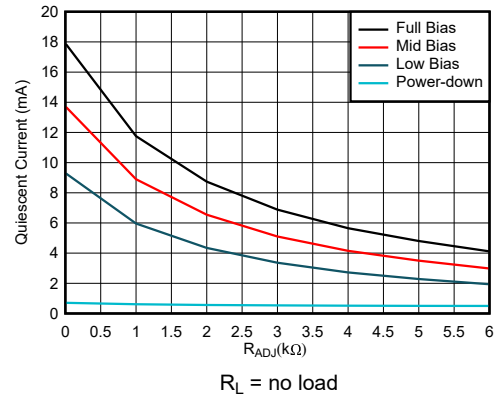


Figure 6-32. Quiescent Current vs R_{ADJ}

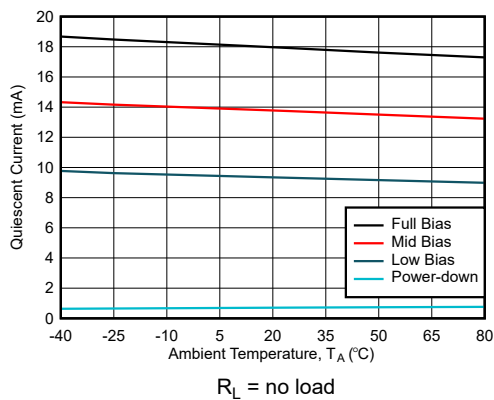


Figure 6-33. Quiescent Current vs Temperature

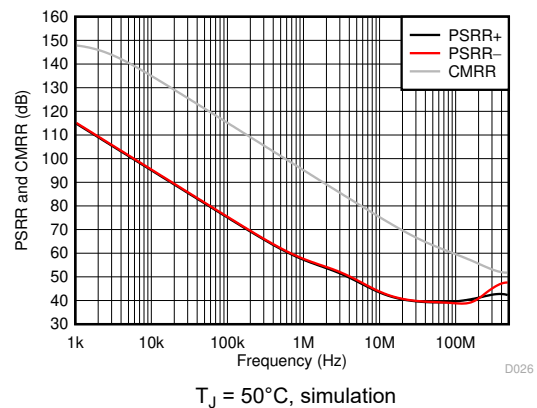


Figure 6-34. PSRR and CMRR vs Frequency

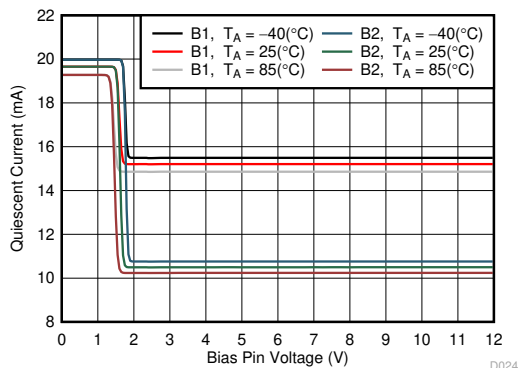


Figure 6-35. Mode Transition Voltage Threshold

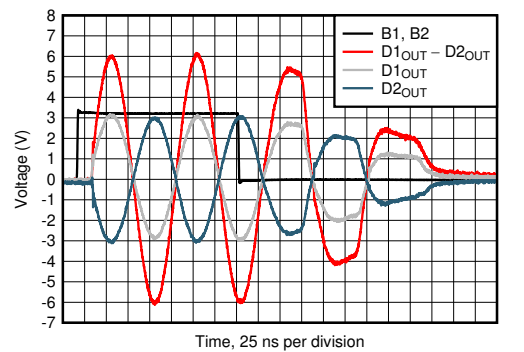


Figure 6-36. Full-Bias and Shutdown Mode Transition Timing

6.9 Typical Characteristics: $V_S = 28\text{ V}$

At $T_A \approx 25^\circ\text{C}$, $A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $R_L = 100\text{ }\Omega$, $R_S = 2.5\text{ }\Omega$, $R_{ADJ} = 0\text{ }\Omega$, full-bias mode (unless otherwise noted).

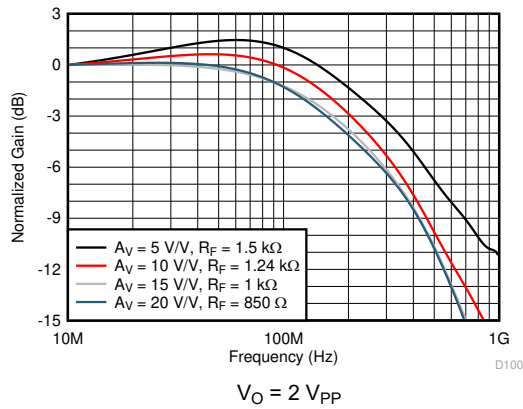


Figure 6-37. Small-Signal Frequency Response

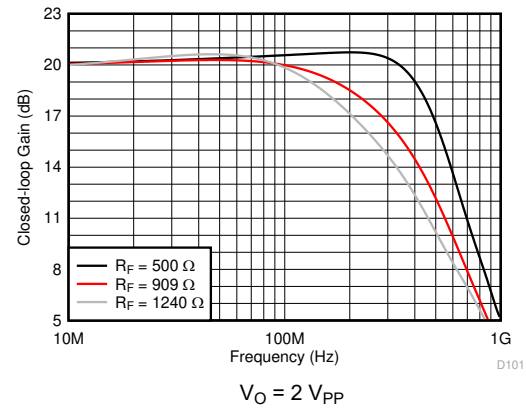


Figure 6-38. Small-Signal Frequency Response vs R_F

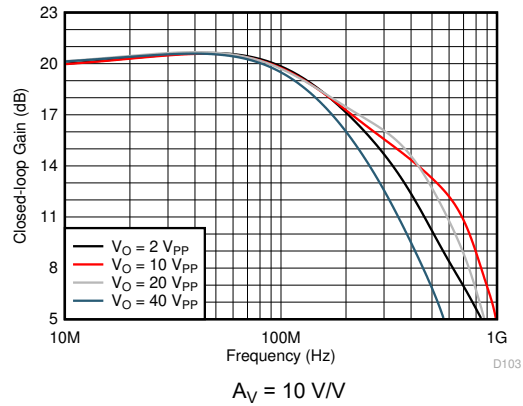


Figure 6-39. Large-Signal Frequency Response vs V_O

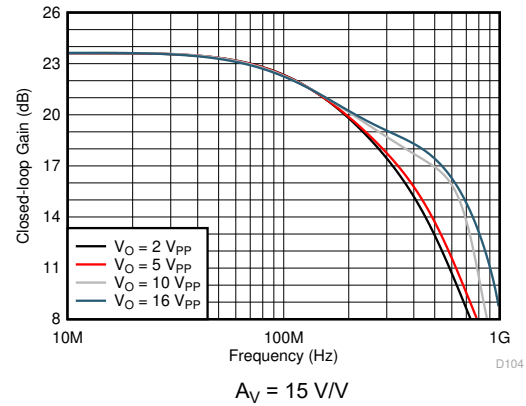


Figure 6-40. Large-Signal Frequency Response vs V_O

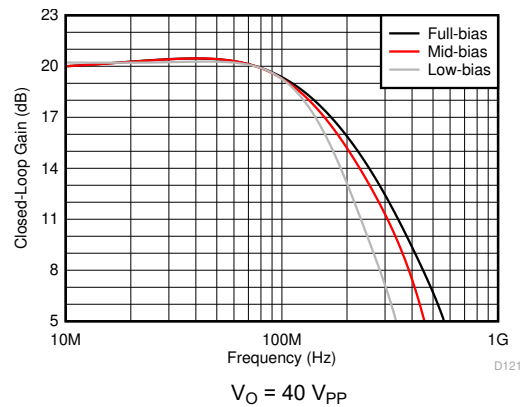


Figure 6-41. Large-Signal Frequency Response vs Bias Modes

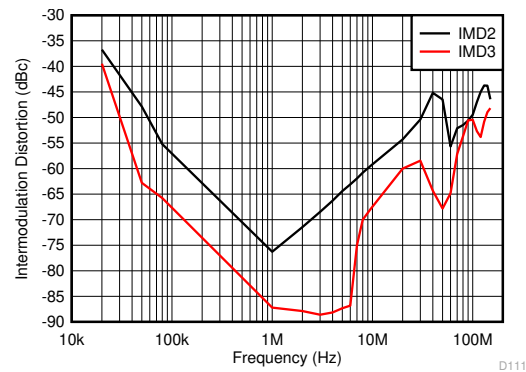


Figure 6-42. Intermodulation Distortion vs Frequency

6.9 Typical Characteristics: $V_S = 28\text{ V}$ (continued)

At $T_A \approx 25^\circ\text{C}$, $A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $R_L = 100\text{ }\Omega$, $R_S = 2.5\text{ }\Omega$, $R_{ADJ} = 0\text{ }\Omega$, full-bias mode (unless otherwise noted).

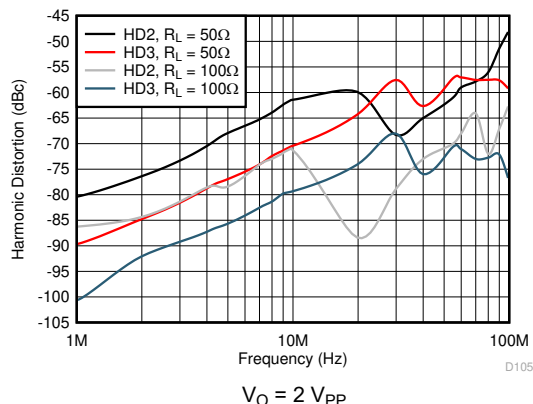


Figure 6-43. Harmonic Distortion vs Frequency

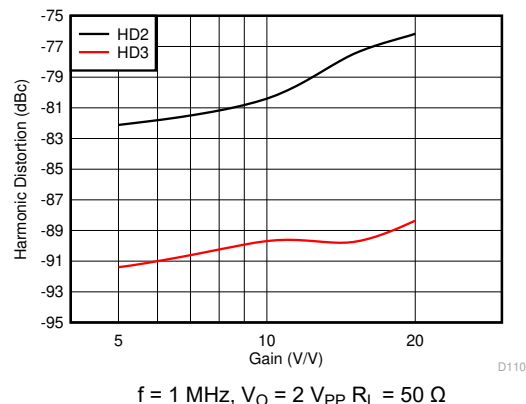


Figure 6-44. Harmonic Distortion vs Gain

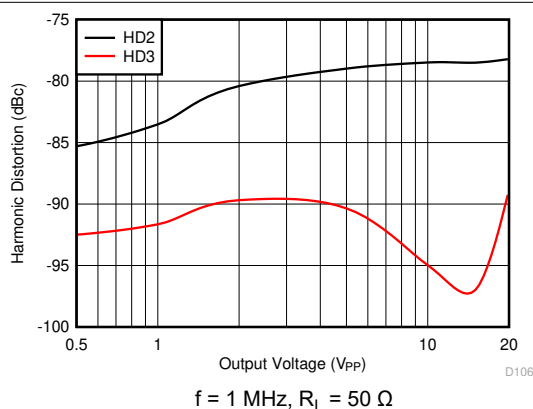


Figure 6-45. Harmonic Distortion vs V_O

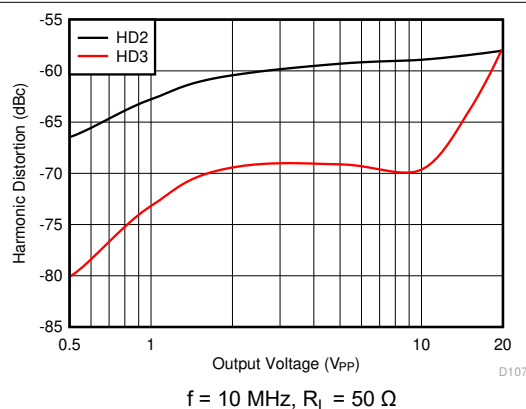


Figure 6-46. Harmonic Distortion vs V_O

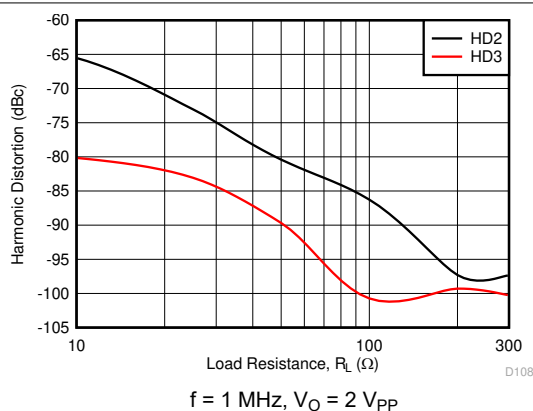


Figure 6-47. Harmonic Distortion vs R_L

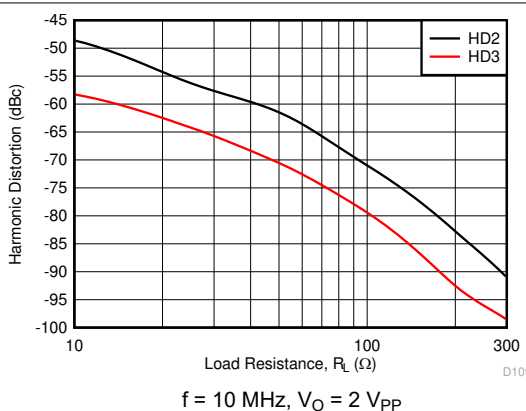


Figure 6-48. Harmonic Distortion vs R_L

6.9 Typical Characteristics: $V_S = 28\text{ V}$ (continued)

At $T_A \approx 25^\circ\text{C}$, $A_V = 10\text{ V/V}$, $R_F = 1.24\text{ k}\Omega$, $R_L = 100\text{ }\Omega$, $R_S = 2.5\text{ }\Omega$, $R_{ADJ} = 0\text{ }\Omega$, full-bias mode (unless otherwise noted).

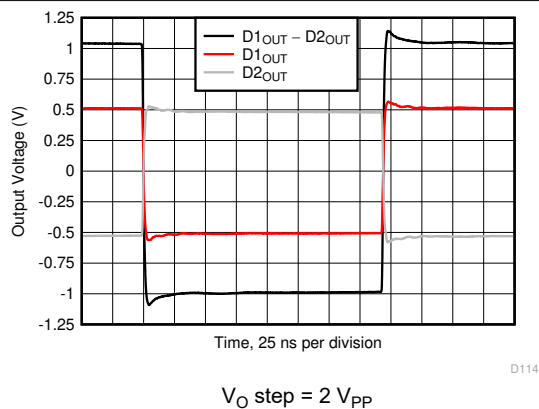


Figure 6-49. Small-Signal Pulse Response

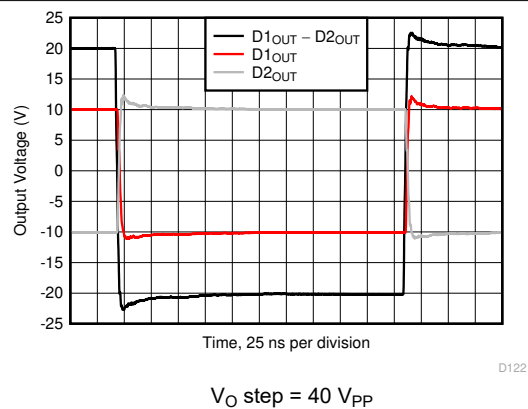


Figure 6-50. Large-Signal Pulse Response

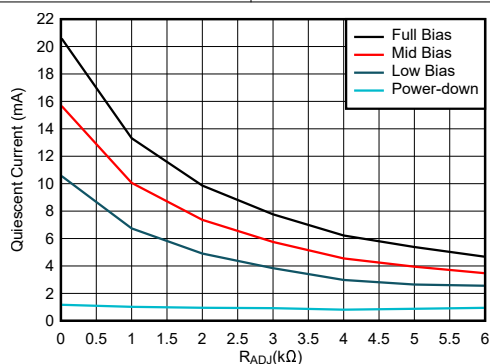


Figure 6-51. Quiescent Current vs R_{ADJ}

7 Detailed Description

7.1 Overview

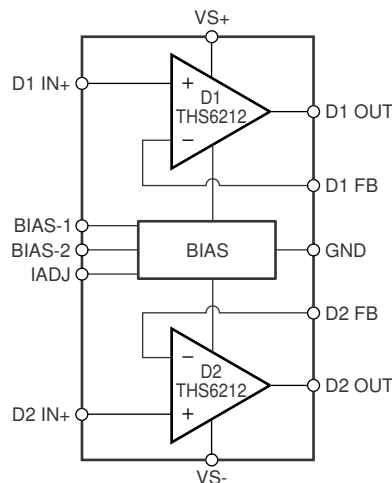
The THS6212 is a differential line-driver amplifier with a current-feedback architecture. The device is targeted for use in line-driver applications (such as wide-band power-line communications) and is fast enough to support transmissions of 14.5-dBm line power up to 30 MHz.

The THS6212 is designed as a single-channel solution that can be a drop-in replacement for dual-channel footprint packages. The package pinout is compatible with the pinout of the THS6214 dual, differential line driver, and provides an alternative for systems that only require a single-channel device.

The architecture of the THS6212 is designed to provide maximum flexibility with multiple bias settings that are selectable based on application performance requirements, and also provides an external current pin (IADJ) to further adjust the bias current to the device. The wide output swing (49 V_{PP}) and high current drive (650-mA) of the THS6212 make the device ideally suited for high-power, line-driving applications.

The THS6212 features thermal protection that typically triggers at a junction temperature of 175°C. The device behavior is similar to the bias off mode when thermal shutdown is activated. The device resumes normal operation when the die junction temperature reaches approximately 145°C. The device may go in and out of thermal shutdown until the overload conditions are removed because of the unpredictable behavior of the overload and thermal characteristics.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Output Voltage and Current Drive

The THS6212 provides output voltage and current capabilities that are unsurpassed in a low-cost, monolithic op amp. The output voltage (under no load at room temperature) typically swings closer than 1.1 V to either supply rail and typically swings to within 1.1 V of either supply with a 100 Ω differential load. The THS6212 can deliver over 350 mA of current with a 25 Ω load.

Good thermal design of the system is important, including use of heat sinks and active cooling methods, if the THS6212 is pushed to the limits of its output drive capabilities. Figure 7-1 and Figure 7-2 show the output drive of the THS6212 under two different sets of conditions where T_A is approximately equal to T_J . In practical applications, T_J is often much higher than T_A and is highly dependent on the device configuration, signal parameters, and PCB thermal design. In order to represent the full output drive capability of the THS6212 in Figure 7-1 and Figure 7-2, $T_J \approx T_A$ is achieved by pulsing or sweeping the output current for a duration of less than 100 ms.

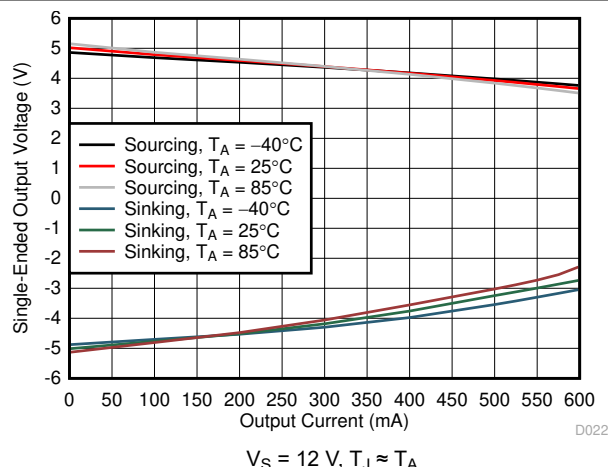


Figure 7-1. Slammed Single-Ended Output Voltage vs I_O and Temperature

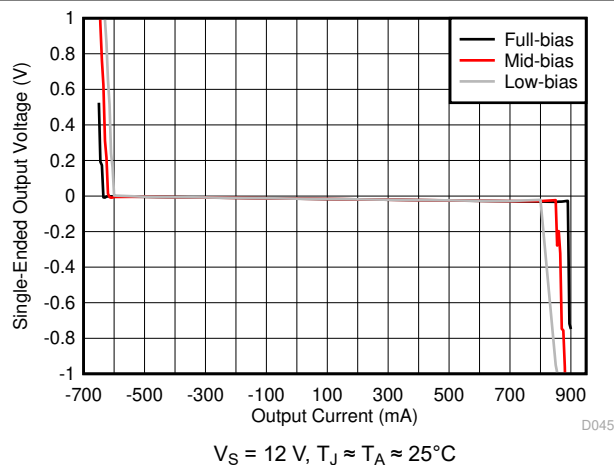


Figure 7-2. Linear Single-Ended Output Voltage vs I_O and Temperature

In [Figure 7-1](#), the output voltages are differentially slammed to the rail and the output current is single-endedly sourced or sunk using a source measure unit (SMU) for less than 100 ms. The single-ended output voltage of each output is then measured prior to removing the load current. After removing the load current, the outputs are brought back to mid-supply before repeating the measurement for different load currents. This entire process is repeated for each ambient temperature. Under the slammed output voltage condition of [Figure 7-1](#), the output transistors are in saturation and the transistors start going into linear operation as the output swing is backed off for a given I_O .

In [Figure 7-2](#), the inputs are floated and the output voltages are allowed to settle to the mid-supply voltage. The load current is then single-endedly swept for sourcing (greater than 0 mA) and sinking (less than 0 mA) conditions and the single-ended output voltage is measured at each current-forcing condition. The current sweep is completed in a few seconds (approximately 3 to 4 seconds) so as not to significantly raise the junction temperature (T_J) of the device from the ambient temperature (T_A). The output is not swinging and the output transistors are in linear operation in [Figure 7-2](#) until the current drawn exceeds the device capabilities, at which point the output voltage starts to deviate quickly from the no load output voltage.

To maintain maximum output stage linearity, output short-circuit protection is not provided. This absence of short-circuit protection is normally not a problem because most applications include a series-matching resistor at the output that limits the internal power dissipation if the output side of this resistor is shorted to ground. However, shorting the output pin directly to the adjacent positive power-supply pin, in most cases, permanently damages the amplifier.

7.3.2 Driving Capacitive Loads

One of the most demanding and yet very common load conditions for an op amp is capacitive loading. Often, the capacitive load is the input of an ADC—including additional external capacitance that can be recommended to improve the ADC linearity. A high-speed, high open-loop gain amplifier such as the THS6212 can be very susceptible to decreased stability and closed-loop response peaking when a capacitive load is placed directly on the output pin. When the amplifier open-loop output resistance is considered, this capacitive load introduces an additional pole in the signal path that can decrease the phase margin. One external solution to this problem is described in this section.

When the primary considerations are frequency response flatness, pulse response fidelity, and distortion, the simplest and most effective solution is to isolate the capacitive load from the feedback loop by inserting a series isolation resistor between the amplifier output and the capacitive load. This series resistor does not eliminate the pole from the loop response, but shifts the pole and adds a zero at a higher frequency. The additional zero functions to cancel the phase lag from the capacitive load pole, thus increasing the phase margin and improving stability.

The [Typical Characteristics](#) sections describe the recommended R_S versus capacitive load (see [Figure 6-10](#)) and the resulting frequency response at the load. Parasitic capacitive loads greater than 2 pF can begin to degrade device performance. Long printed-circuit board (PCB) traces, unmatched cables, and connections to multiple devices can easily cause this value to be exceeded. Always consider this effect carefully, and add the recommended series resistor as close as possible to the THS6212 output pin (see the [Layout Guidelines](#) section).

7.3.3 Distortion Performance

The THS6212 provides good distortion performance into a 100- Ω load on a 28-V supply. Relative to alternative solutions, the amplifier provides exceptional performance into lighter loads and operation on a 12 V supply. Generally, until the fundamental signal reaches very high frequency or power levels, the second harmonic dominates the distortion with a negligible third-harmonic component. Focusing then on the second harmonic, increasing the load impedance improves distortion directly. Remember that the total load includes the feedback network—in the noninverting configuration (see [Figure 8-1](#)), this value is the sum of $R_F + R_G$, whereas in the inverting configuration this value is just R_F . Providing an additional supply decoupling capacitor (0.01 μ F) between the supply pins (for bipolar operation) also improves the second-order distortion slightly (from 3 dB to 6 dB).

In most op amps, increasing the output voltage swing directly increases harmonic distortion. The [Typical Characteristics](#) sections illustrate the second harmonic increasing at a little less than the expected 2x rate, whereas the third harmonic increases at a little less than the expected 3x rate. Where the test power doubles, the difference between the fundamental power and the second harmonic decreases less than the expected 6 dB, whereas the difference between the fundamental power and the third harmonic decreases by less than the expected 12 dB. This difference also appears in the two-tone, third-order intermodulation (IM3) spurious response curves. The third-order spurious levels are extremely low at low-output power levels. The output stage continues to hold the third-order spurious levels low even when the fundamental power reaches very high levels.

7.3.4 Differential Noise Performance

The THS6212 is designed to be used as a differential driver in high-performance applications. Therefore, analyzing the noise in such a configuration is important. [Figure 7-3](#) shows the op amp noise model for the differential configuration.

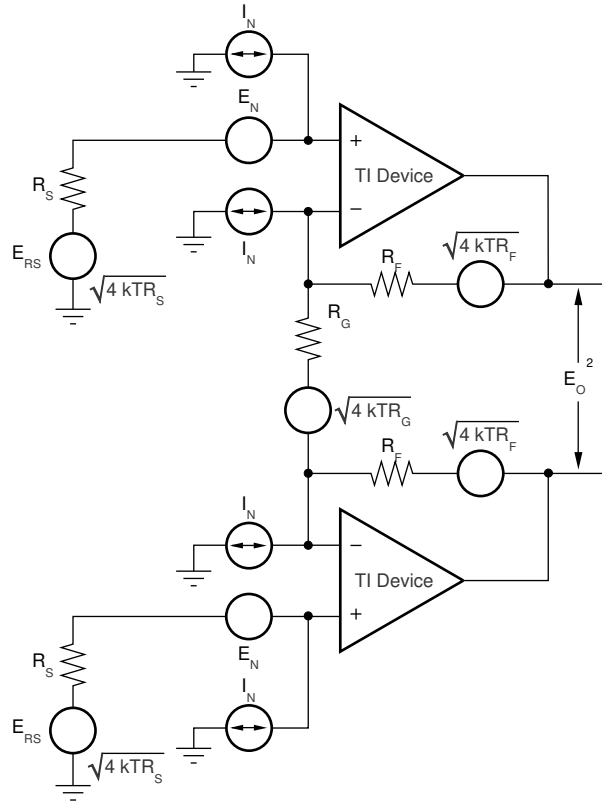


Figure 7-3. Differential Op Amp Noise Analysis Model

As a reminder, the differential gain is expressed in [Equation 1](#):

$$G_D = 1 + \frac{2 \times R_F}{R_G} \quad (1)$$

The output noise can be expressed as shown in [Equation 2](#):

$$E_O = \sqrt{2 \times G_D^2 \times \left[e_N^2 + (i_N \times R_S)^2 + 4 kTR_S \right] + 2(i_I R_F)^2 + 2(4 kTR_F G_D)} \quad (2)$$

Dividing this expression by the differential noise gain [$G_D = (1 + 2R_F / R_G)$] gives the equivalent input-referred spot noise voltage at the noninverting input, as shown in [Equation 3](#).

$$E_O = \sqrt{2 \times \left[e_N^2 + (i_N \times R_S)^2 + 4 kTR_S \right] + 2 \left(\frac{i_I R_F}{G_D} \right)^2 + 2 \left(\frac{4 kTR_F}{G_D} \right)} \quad (3)$$

Evaluating these equations for the THS6212 circuit and component values of [Figure 8-1](#) with $R_S = 50 \Omega$, gives a total output spot noise voltage of 53.3 nV/ $\sqrt{\text{Hz}}$ and a total equivalent input spot noise voltage of 6.5 nV/ $\sqrt{\text{Hz}}$.

In order to minimize the output noise as a result of the noninverting input bias current noise, keeping the noninverting source impedance as low as possible is recommended.

7.3.5 DC Accuracy and Offset Control

A current-feedback op amp such as the THS6212 provides exceptional bandwidth in high gains, giving fast pulse settling but only moderate dc accuracy. The [Electrical Characteristics](#) tables describe an input offset voltage that is comparable to high-speed, voltage-feedback amplifiers; however, the two input bias currents are somewhat higher and are unmatched. Although bias current cancellation techniques are very effective with most voltage-feedback op amps, these techniques do not generally reduce the output dc offset for wideband current-feedback op amps. Because the two input bias currents are unrelated in both magnitude and polarity, matching the input source impedance to reduce error contribution to the output is ineffective. Evaluating the configuration of [Figure 8-1](#), using a typical condition at 25°C input offset voltage and the two input bias currents, gives a typical output offset range equal to [Equation 4](#):

$$\begin{aligned}
 V_{\text{OFF}} &= \left(\pm \text{NG} \times V_{\text{OS(TYP)}} \right) + \left(I_{\text{BN}} \times \frac{R_{\text{S}}}{2} \times \text{NG} \right) \pm (I_{\text{BI}} \times R_{\text{F}}) \\
 &= \pm (10 \times 0.5\text{mV}) + (1\mu\text{A} \times 25\Omega \times 10) \pm (6\mu\text{A} \times 1.24\text{k}\Omega) \\
 &= \pm 5\text{mV} + 0.250\text{mV} \pm 7.44\text{mV} \\
 V_{\text{OFF}} &= -12.19\text{mV to } 12.69\text{mV}
 \end{aligned}
 \tag{4}$$

where

- NG = noninverting signal gain

7.4 Device Functional Modes

The THS6212 has four different functional modes set by the BIAS-1 and BIAS-2 pins. [Table 7-1](#) shows the truth table for the device mode pin configuration and the associated description of each mode.

Table 7-1. BIAS-1 and BIAS-2 Logic Table

BIAS-1	BIAS-2	FUNCTION	DESCRIPTION
0	0	Full-bias mode (100%)	Amplifiers on with lowest distortion possible (default state)
1	0	Mid-bias mode (75%)	Amplifiers on with power savings and a reduction in distortion performance
0	1	Low-bias mode (50%)	Amplifiers on with enhanced power savings and a reduction of overall performance
1	1	Shutdown mode	Amplifiers off and output has high impedance

8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The THS6212 is typically used to drive high output power applications with various load conditions. In the [Typical Applications](#) section, the amplifier is presented in a general-purpose, wideband, current-feedback configuration, and a more specific 100-Ω twisted pair cable line driver; however, the amplifier is also applicable for many different general-purpose and specific cable line-driving scenarios beyond what is shown in the [Typical Applications](#) section.

8.2 Typical Applications

8.2.1 Wideband Current-Feedback Operation

The THS6212 provides the exceptional ac performance of a wideband current-feedback op amp with a highly linear, high-power output stage. Requiring only 19.5 mA of quiescent current, the THS6212 has an output swing of 49 V_{pp} (100-Ω load) coupled with over 650 mA current drive (25 Ω load). This low-output headroom requirement, along with biasing that is independent of the supply voltage, provides a remarkable 28-V supply operation. The THS6212 delivers greater than 285-MHz bandwidth driving a 2-V_{PP} output into 100 Ω on a 28-V supply. Previous boosted output stage amplifiers typically suffer from very poor crossover distortion when the output current goes through zero. The THS6212 achieves a comparable power gain with improved linearity. The primary advantage of a current-feedback op amp over a voltage-feedback op amp is that ac performance (bandwidth and distortion) is relatively independent of signal gain. [Figure 8-1](#) shows the dc-coupled, gain of 10 V/V, dual power-supply circuit configuration used as the basis of the 28-V [Electrical Characteristics](#) tables and [Typical Characteristics](#) sections.

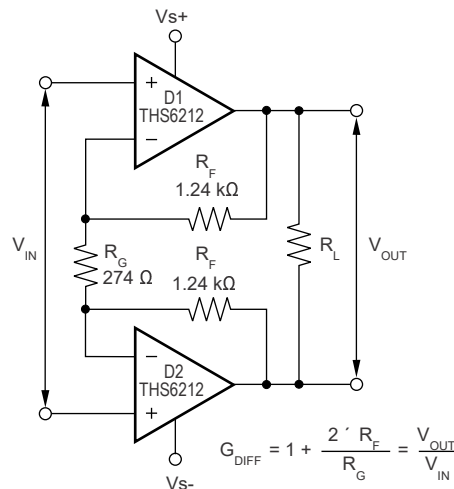


Figure 8-1. Noninverting Differential I/O Amplifier

8.2.1.1 Design Requirements

The main design requirements for wideband current-feedback operation are to choose power supplies that satisfy common-mode requirements at the input and output of the device, and also to use a feedback resistor value that allows for the proper bandwidth when maintaining stability. These requirements and the proper solutions are described in the [Detailed Design Procedure](#) section. Using transformers and split power supplies can be required for certain applications.

8.2.1.2 Detailed Design Procedure

For ease of test purposes in this design, the THS6212 input impedance is set to 50 Ω with a resistor to ground and the output impedance is set to 50 Ω with a series output resistor. Voltage swings reported in the [Electrical Characteristics](#) tables are taken directly at the input and output pins, whereas load powers (dBm) are defined at a matched 50- Ω load. For the circuit of [Figure 8-1](#), the total effective load is $100\ \Omega \parallel 1.24\ \text{k}\Omega \parallel 1.24\ \text{k}\Omega = 86.1\ \Omega$. This approach allows a source termination impedance to be set at the input that is independent of the signal gain. For instance, simple differential filters can be included in the signal path right up to the noninverting inputs with no interaction with the gain setting. The differential signal gain for the circuit of [Figure 8-1](#) is given by [Equation 5](#):

$$A_D = 1 + 2 \times \frac{R_F}{R_G} \quad (5)$$

where

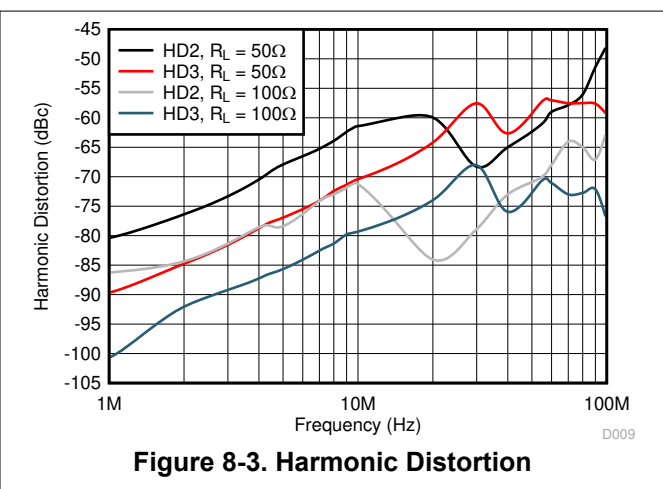
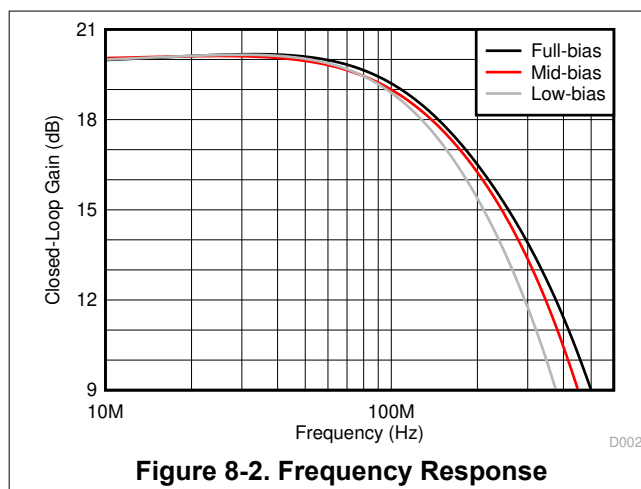
- A_D = differential gain

A value of 274 Ω for the $A_D = 10\text{-V/V}$ design is given by [Figure 8-1](#). The device bandwidth is primarily controlled with the feedback resistor value because the THS6212 is a current-feedback (CFB) amplifier; the differential gain, however, can be adjusted with considerable freedom using just the R_G resistor. In fact, R_G can be reduced by a reactive network that provides a very isolated shaping to the differential frequency response.

Various combinations of single-supply or ac-coupled gain can also be delivered using the basic circuit of [Figure 8-1](#). Common-mode bias voltages on the two noninverting inputs pass on to the output with a gain of 1 V/V because an equal dc voltage at each inverting node does not create current through R_G . This circuit does show a common-mode gain of 1 V/V from the input to output. The source connection must either remove this common-mode signal if undesired (using an input transformer can provide this function), or the common-mode voltage at the inputs can be used to set the output common-mode bias. If the low common-mode rejection of this circuit is a problem, the output interface can also be used to reject that common-mode signal. For instance, most modern differential input analog-to-digital converters (ADCs) reject common-mode signals very well, and a line-driver application through a transformer also attenuates the common-mode signal through to the line.

8.2.1.3 Application Curves

[Figure 8-2](#) and [Figure 8-3](#) show the frequency response and distortion performance of the circuit in [Figure 8-1](#). The measurements are made with a load resistor (R_L) of 100 Ω , and at room temperature. [Figure 8-2](#) is measured using the three different device power modes, and the distortion measurements in [Figure 8-3](#) are made at an output voltage level of 2 V_{PP}.



8.2.2 Dual-Supply Downstream Driver

Figure 8-4 shows an example of a dual-supply downstream driver with a synthesized output impedance circuit. The THS6212 is configured as a differential gain stage to provide a signal drive to the primary winding of the transformer (a step-up transformer with a turns ratio of 1:n is shown in Figure 8-4). The main advantage of this configuration is the cancellation of all even harmonic-distortion products. Another important advantage is that each amplifier must only swing half of the total output required driving the load.

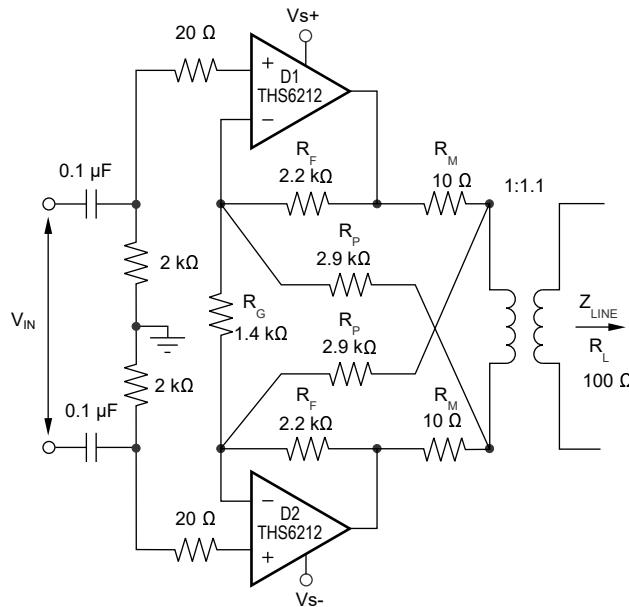


Figure 8-4. Dual-Supply Downstream Driver

The analog front-end (AFE) signal is ac-coupled to the driver, and the noninverting input of each amplifier is biased to the mid-supply voltage (ground in this case). In addition to providing the proper biasing to the amplifier, this approach also provides a high-pass filtering with a corner frequency that is set at 5 kHz in this example. Because the signal bandwidth starts at 26 kHz, this high-pass filter does not generate any problems and has the advantage of filtering out unwanted lower frequencies.

8.2.2.1 Design Requirements

The main design requirements for Figure 8-4 are to match the output impedance correctly, satisfy headroom requirements, and ensure that the circuit meets power driving requirements. These requirements are described in the [Detailed Design Procedure](#) section and include the required equations to properly implement the design. The design must be fully worked through before physical implementation because small changes in a single parameter can often have large effects on performance.

8.2.2.2 Detailed Design Procedure

For Figure 8-4, the input signal is amplified with a gain set by Equation 6:

$$G_D = 1 + \frac{2 \times R_F}{R_G} \quad (6)$$

The two back-termination resistors ($R_M = 10\ \Omega$, each) added at each terminal of the transformer make the impedance of the amplifier match the impedance of the line, and also provide a means of detecting the received signal for the receiver. The value of these resistors (R_M) is a function of the line impedance and the transformer turns ratio (n), given by Equation 7:

$$R_M = \frac{Z_{\text{LINE}}}{2n^2} \quad (7)$$

8.2.2.2.1 Line Driver Headroom Requirements

The first step in a transformer-coupled, twisted-pair driver design is to compute the peak-to-peak output voltage from the target specifications. This calculation is done using Equation 8 to Equation 11:

$$P_L = 10 \times \log \frac{V_{\text{RMS}}^2}{(1\ \text{mW}) \times R_L} \quad (8)$$

where

- P_L = power at the load
- V_{RMS} = voltage at the load
- R_L = load impedance

These values produce the following:

$$V_{\text{RMS}} = \sqrt{(1\ \text{mW}) \times R_L \times 10 \frac{P_L}{10}} \quad (9)$$

$$V_P = \text{Crest Factor} \times V_{\text{RMS}} = \text{CF} \times V_{\text{RMS}} \quad (10)$$

where

- V_P = peak voltage at the load
- CF = crest factor

$$V_{\text{LPP}} = 2 \times \text{CF} \times V_{\text{RMS}} \quad (11)$$

where

- V_{LPP} = peak-to-peak voltage at the load

Consolidating Equation 8 to Equation 11 allows the required peak-to-peak voltage at the load to be expressed as a function of the crest factor, the load impedance, and the power at the load, as given by Equation 12:

$$V_{\text{LPP}} = 2 \times \text{CF} \times \sqrt{(1\ \text{mW}) \times R_L \times 10 \frac{P_L}{10}} \quad (12)$$

V_{LPP} is usually computed for a nominal line impedance and can be taken as a fixed design target.

The next step in the design is to compute the individual amplifier output voltage and currents as a function of peak-to-peak voltage on the line and transformer-turns ratio.

When this turns ratio changes, the minimum allowed supply voltage also changes. The peak current in the amplifier output is given by Equation 13:

$$\pm I_P = \frac{1}{2} \times \frac{2 \times V_{\text{LPP}}}{n} \times \frac{1}{4 R_M} \quad (13)$$

where

- V_{PP} is as defined in Equation 12, and
- R_M is as defined in Equation 7 and Figure 8-5

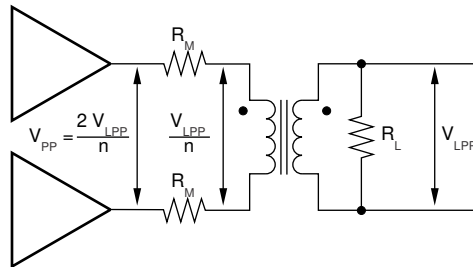


Figure 8-5. Driver Peak Output Voltage

With the previous information available, a supply voltage and the turns ratio desired for the transformer can now be selected, and the headroom for the THS6212 can be calculated.

The model shown in Figure 8-6 can be described with Equation 14 and Equation 15 as:

1. The available output swing:

$$V_{PP} = V_{CC} - (V_1 + V_2) - I_P \times (R_1 + R_2) \quad (14)$$

2. Or as the required supply voltage:

$$V_{CC} = V_{PP} + (V_1 + V_2) + I_P \times (R_1 + R_2) \quad (15)$$

The minimum supply voltage for power and load requirements is given by Equation 15.

V_1 , V_2 , R_1 , and R_2 are given in Table 8-1 for the ± 14 -V operation.

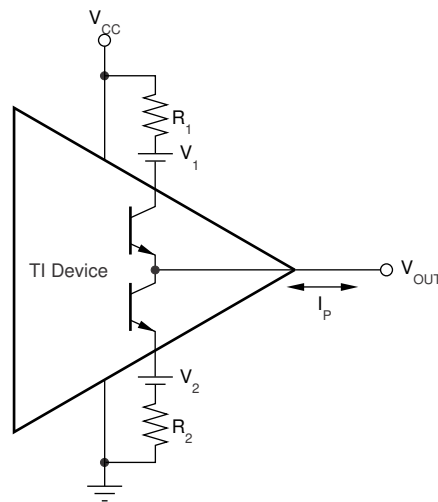


Figure 8-6. Line Driver Headroom Model

Table 8-1. Line Driver Headroom Model Values

V_S	V_1	R_1	V_2	R_2
± 14 V	1 V	0.6 Ω	1 V	1.2 Ω

When using a synthetic output impedance circuit (see Figure 8-4), a significant drop in bandwidth occurs from the specification provided in the [Electrical Characteristics](#) tables. This apparent drop in bandwidth for the differential signal is a result of the apparent increase in the feedback transimpedance for each amplifier. This feedback transimpedance equation is given by Equation 16:

$$Z_{FB} = R_F \times \frac{1 + 2 \times \frac{R_S}{R_L} + \frac{R_S}{R_P}}{1 + 2 \times \frac{R_S}{R_L} + \frac{R_S}{R_P} - \frac{R_F}{R_P}} \quad (16)$$

To increase the 0.1-dB flatness to the frequency of interest, adding a serial RC in parallel with the gain resistor may be needed, as shown in Figure 8-7.

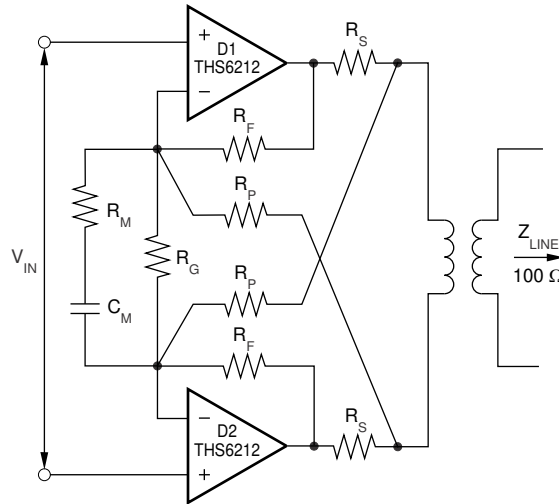


Figure 8-7. 0.1-dB Flatness Compensation Circuit

8.2.2.2.2 Computing Total Driver Power for Line-Driving Applications

The total internal power dissipation for the THS6212 in a line-driver application is the sum of the quiescent power and the output stage power. The THS6212 holds a relatively constant quiescent current versus supply voltage—giving a power contribution that is simply the quiescent current times the supply voltage used (the supply voltage is greater than the solution given in Equation 15). The total output stage power can be computed with reference to Figure 8-8.

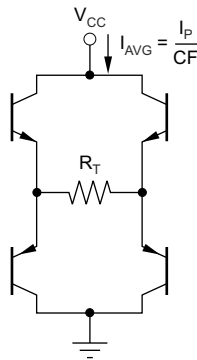


Figure 8-8. Output Stage Power Model

The two output stages used to drive the load of Figure 8-5 are shown as an H-Bridge in Figure 8-8. The average current drawn from the supply into this H-Bridge and load is the peak current in the load given by Equation 13 divided by the crest factor (CF) for the signal modulation. This total power from the supply is then reduced by the power in R_T , leaving the power dissipated internal to the drivers in the four output stage transistors. That power is simply the target line power used in Equation 8 plus the power lost in the matching elements (R_M). In the following examples, a perfect match is targeted giving the same power in the matching elements as in the load. The output stage power is then set by Equation 17.

$$P_{OUT} = \frac{I_p}{CF} \times V_{CC} - 2P_L \quad (17)$$

The total amplifier power is then given by [Equation 18](#):

$$P_{TOT} = I_Q \times V_{CC} + \frac{I_p}{CF} \times V_{CC} - 2P_L \quad (18)$$

For the example given by [Figure 8-4](#), the peak current is 159 mA for a signal that requires a crest factor of 5.6 with a target line power of 20.5 dBm into a 100-Ω load (115 mW).

With a typical quiescent current of 19.5 mA and a nominal supply voltage of ±14 V, the total internal power dissipation for the solution of [Figure 8-4](#) is given by [Equation 19](#):

$$P_{TOT} = 19.5\text{mA}(28\text{V}) + \frac{159\text{mA}}{5.6}(28\text{V}) - 2(115\text{mW}) = 1111\text{mW} \quad (19)$$

8.3 What To Do and What Not to Do

8.3.1 What To Do

- Include a thermal design at the beginning of the project.
- Use well-terminated transmission lines for all signals.
- Use solid metal layers for the power supplies.
- Keep signal lines as straight as possible.
- Use split supplies where required.

8.3.2 What Not to Do

- Use a lower supply voltage than necessary.
- Use thin metal traces to supply power.
- Forget about the common-mode response of filters and transmission lines.

9 Power Supply Recommendations

The THS6212 is designed to operate optimally using split power supplies. The device has a very wide supply range of 10 V to 28 V to accommodate many different application scenarios. Choose power-supply voltages that allow for adequate swing on both the inputs and outputs of the amplifier to prevent affecting device performance. The ground pin provides the ground reference for the control pins and must be within V_{S-} to $(V_{S+} - 5\text{ V})$ for proper operation.

10 Layout

10.1 Layout Guidelines

Achieving optimum performance with a high-frequency amplifier such as the THS6212 requires careful attention to board layout parasitic and external component types. Recommendations that optimize performance include:

1. Minimize parasitic capacitance to any ac ground for all signal I/O pins. Parasitic capacitance on the output and inverting input pins can cause instability; on the noninverting input, this capacitance can react with the source impedance to cause unintentional band limiting. To reduce unwanted capacitance, a window around the signal I/O pins must be opened in all ground and power planes around these pins. Otherwise, ground and power planes must be unbroken elsewhere on the board.
2. Minimize the distance (less than 0.25 in, or 6.35 mm) from the power-supply pins to high-frequency 0.1- μ F decoupling capacitors. At the device pins, the ground and power plane layout must not be in close proximity to the signal I/O pins. Avoid narrow power and ground traces to minimize inductance between the pins and the decoupling capacitors. The power-supply connections must always be decoupled with these capacitors. An optional supply decoupling capacitor across the two power supplies (for bipolar operation) improves second-harmonic distortion performance. Larger (2.2 μ F to 6.8 μ F) decoupling capacitors, effective at lower frequencies, must also be used on the main supply pins. These capacitors can be placed somewhat farther from the device and can be shared among several devices in the same area of the PCB.
3. Careful selection and placement of external components preserve the high-frequency performance of the THS6212. Resistors must be of a very low reactance type. Surface-mount resistors work best and allow a tighter overall layout. Metal film and carbon composition, axially-leaded resistors can also provide good high-frequency performance.

Again, keep leads and PCB trace length as short as possible. Never use wire-wound type resistors in a high-frequency application. Although the output pin and inverting input pin are the most sensitive to parasitic capacitance, always position the feedback and series output resistor, if any, as close as possible to the output pin. Other network components, such as noninverting input termination resistors, must also be placed close to the package. Where double-side component mounting is allowed, place the feedback resistor directly under the package on the other side of the board between the output and inverting input pins. The frequency response is primarily determined by the feedback resistor value as described in the Wideband Current-Feedback Operation [Detailed Design Procedure](#) section. Increasing the value reduces the bandwidth, whereas decreasing the value leads to a more peaked frequency response. The 1.24-k Ω feedback resistor used in the [Typical Characteristics](#) sections at a gain of 10 V/V on 28-V supplies is a good starting point for design. Note that a 1.5-k Ω feedback resistor, rather than a direct short, is recommended for a unity-gain follower application. A current-feedback op amp requires a feedback resistor to control stability even in the unity-gain follower configuration.

4. Connections to other wideband devices on the board can be made with short direct traces or through onboard transmission lines. For short connections, consider the trace and the input to the next device as a lumped capacitive load. Relatively wide traces (50 mils to 100 mils [0.050 in to 0.100 in, or 1.27 mm to 2.54 mm]) must be used, preferably with ground and power planes opened up around them. Estimate the total capacitive load and set R_S from the recommended R_S versus capacitive load plots (see [Figure 6-10](#)). Low parasitic capacitive loads (less than 5 pF) may not need an isolation resistor because the THS6212 is nominally compensated to operate with a 2-pF parasitic load. If a long trace is required, and the 6-dB signal loss intrinsic to a doubly-terminated transmission line is acceptable, implement a matched-impedance transmission line using microstrip or stripline techniques (consult an ECL design handbook for microstrip and stripline layout techniques). A 50- Ω environment is not necessary on board; in fact, a higher impedance environment improves distortion (see the distortion versus load plots). With a characteristic board trace impedance defined based on board material and trace dimensions, a matching series resistor into the trace from the output of the THS6212 is used, as well as a terminating shunt resistor at the input of the destination device. Remember also that the terminating impedance is the parallel combination of the shunt resistor and the input impedance of the destination device.

This total effective impedance must be set to match the trace impedance. The high output voltage and current capability of the THS6212 allows multiple destination devices to be handled as separate transmission lines, each with their own series and shunt terminations. If the 6-dB attenuation of a doubly-terminated transmission line is unacceptable, a long trace can be series-terminated at the source end only.

Treat the trace as a capacitive load in this case and set the series resistor value as shown in the recommended R_S versus capacitive load plots. However, this configuration does not preserve signal integrity as well as a doubly-terminated line. If the input impedance of the destination device is low, there is some signal attenuation as a result of the voltage divider formed by the series output into the terminating impedance.

5. Socketing a high-speed part such as the THS6212 is not recommended. The additional lead length and pin-to-pin capacitance introduced by the socket can create an extremely troublesome parasitic network, and can make achieving a smooth, stable frequency response almost impossible. Best results are obtained by soldering the THS6212 directly onto the board.
6. Solder the exposed thermal pad to a heat-spreading power or ground plane. This pad is electrically isolated from the die, but must be connected to a power or ground plane and not floated.

10.2 Layout Example

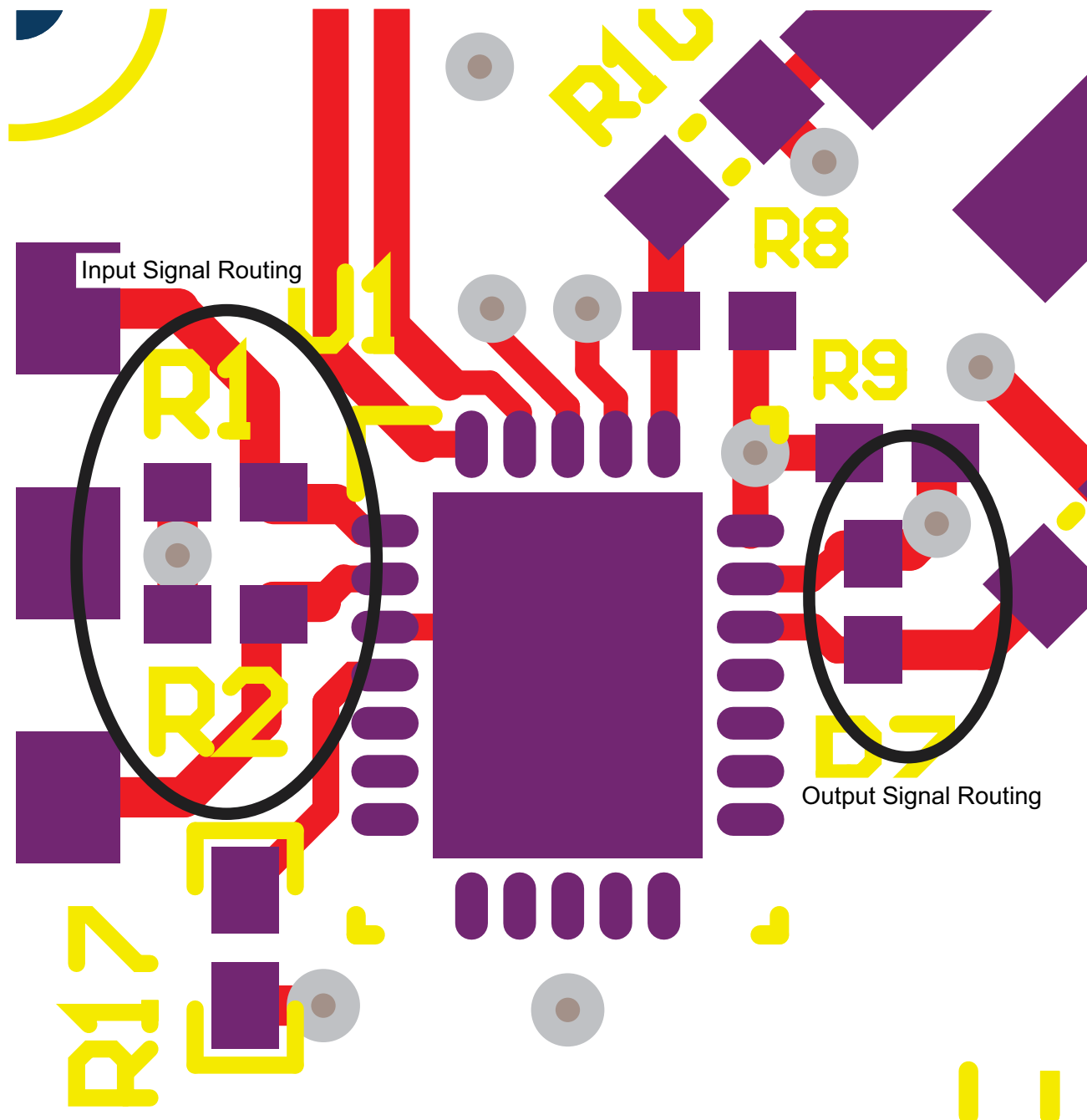


Figure 10-1. THS6212EVM Top Layer Example

Resistors for the optional synthesized output impedance network.

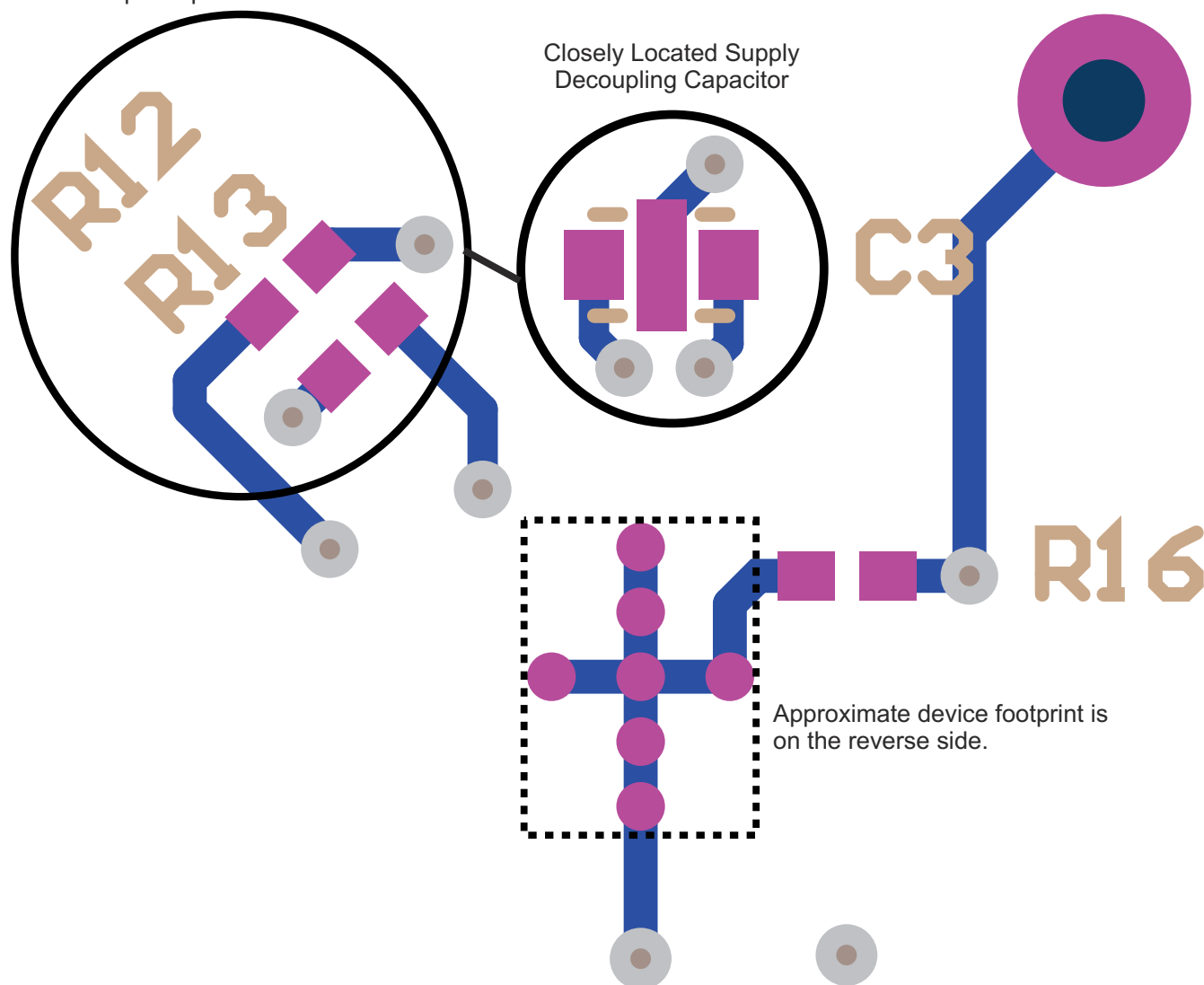


Figure 10-2. THS6212EVM Bottom Layer Example

11 Device and Documentation Support

11.1 Documentation Support

11.1.1 Related Documentation

For related documentation see the following:

- Texas Instruments, [THS6214 Dual-Port, Differential, VDSL2 Line Driver Amplifiers data sheet](#)
- Texas Instruments, [THS6222 8-V to 32-V, Differential Broadband HPLC Line Driver With Common-Mode Buffer data sheet](#)

11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.3 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

11.4 Trademarks

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11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
THS6212IRHFR	ACTIVE	VQFN	RHF	24	3000	RoHS & Green	NIPDAU NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	THS6212	Samples
THS6212IRHFT	ACTIVE	VQFN	RHF	24	250	RoHS & Green	NIPDAU NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	THS6212	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

⁽²⁾ **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

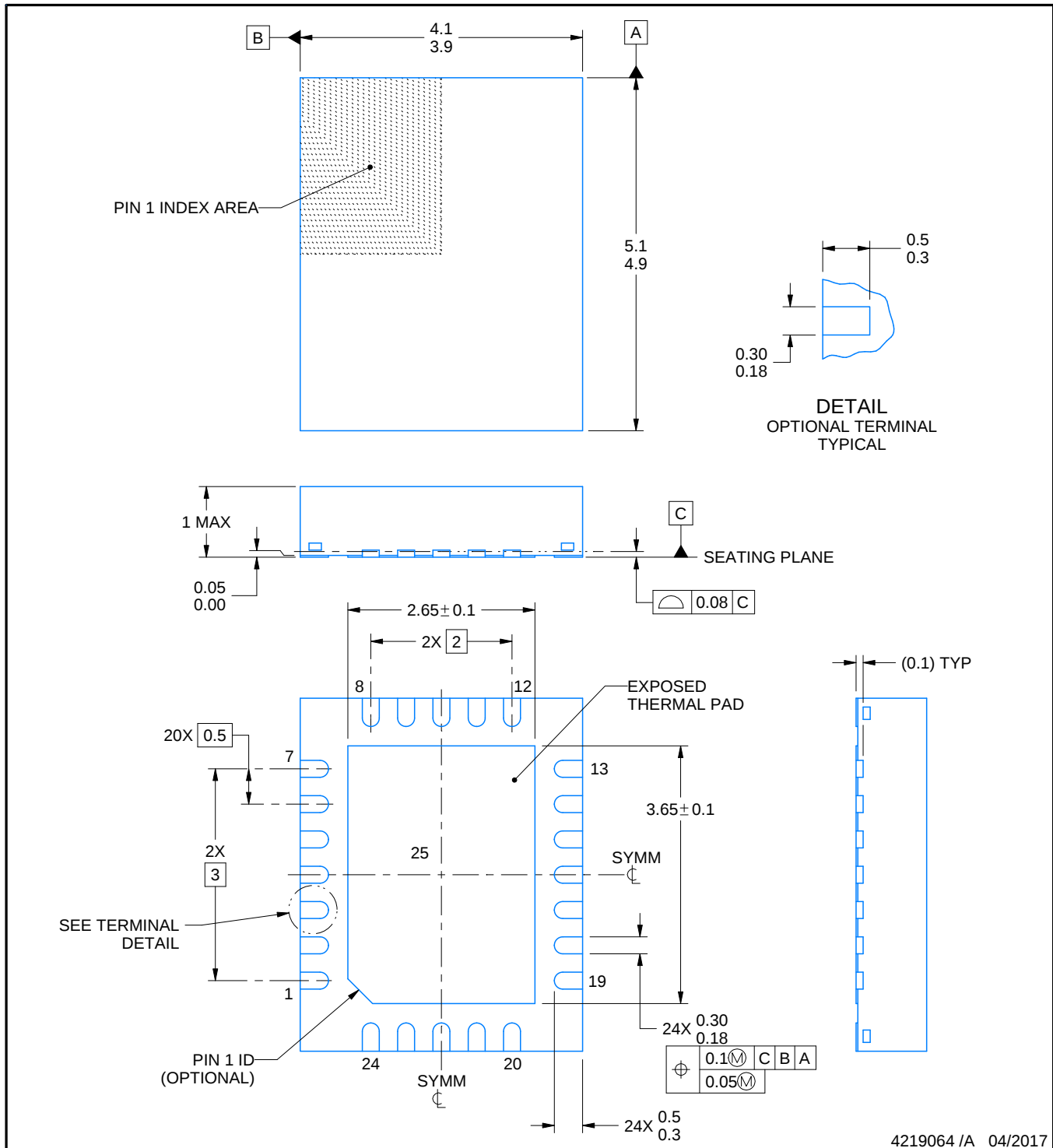
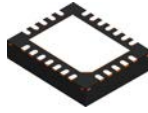
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
THS6212IRHFR	VQFN	RHF	24	3000	330.0	12.4	4.3	5.3	1.3	8.0	12.0	Q1
THS6212IRHFR	VQFN	RHF	24	3000	330.0	12.4	4.3	5.3	1.3	8.0	12.0	Q1
THS6212IRHFT	VQFN	RHF	24	250	180.0	12.4	4.3	5.3	1.3	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
THS6212IRHFR	VQFN	RHF	24	3000	356.0	356.0	35.0
THS6212IRHFR	VQFN	RHF	24	3000	367.0	367.0	35.0
THS6212IRHFT	VQFN	RHF	24	250	210.0	185.0	35.0



NOTES:

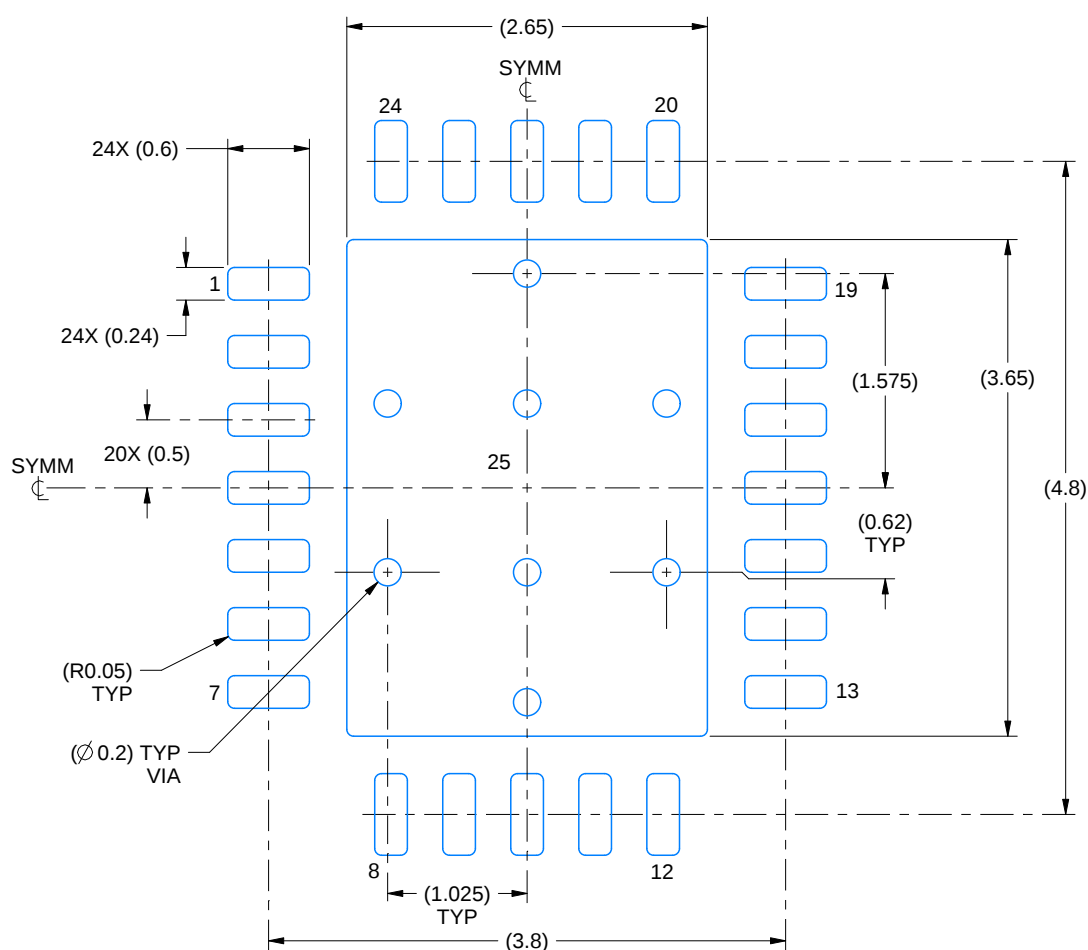
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

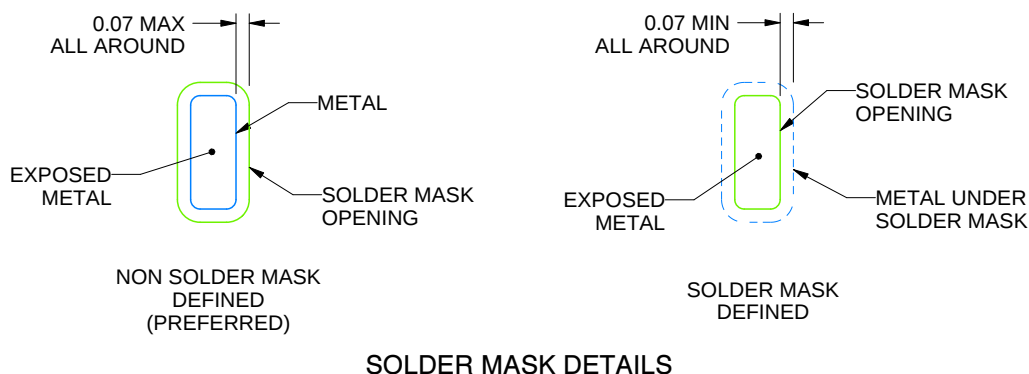
RHF0024A

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:18X



SOLDER MASK DETAILS

4219064 /A 04/2017

NOTES: (continued)

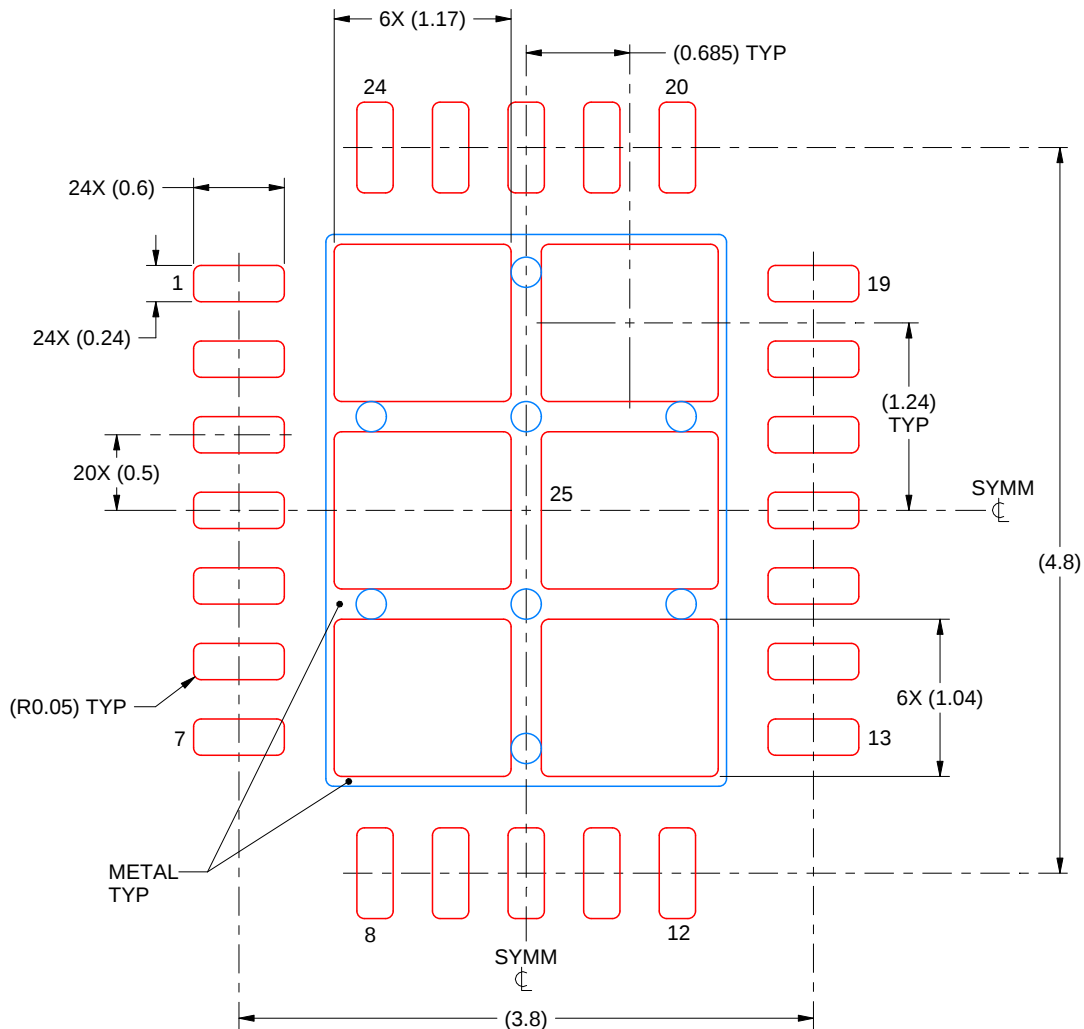
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RHF0024A

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 25
75% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:20X

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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